



M. Flom Associates, Inc. - Global Compliance Center

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T R A N S M I T T E R C E R T I F I C A T I O N

of

FCC ID: LJPNC-1

Serial Number of Unit Tested: 23514034616

to

FEDERAL COMMUNICATIONS COMMISSION

Rule Part(s) 22H, 22.901(d), Confidentiality

DATE OF REPORT: March 8, 2002

ON THE BEHALF OF THE APPLICANT:

Nokia Corporation

AT THE REQUEST OF:

P.O. Kare Oksanen 3/4/02

Nokia Corporation
Elektroniikkatie 10
Fin-90570
Oulu, Finland

Attention of:

Olli Kautio, Senior Engineering Manager,
Testing & Type Approvals
olli.kautio@nokia.com

and/or Kare Oksanen, R&D Type Approvals
kare.oksanen@nokia.com
011 358 105051; FAX: 011 358 10505 7222

SUPERVISED BY:

A handwritten signature in black ink, reading 'M. Flom P. Eng.', is positioned above the printed name of the supervisor.

Morton Flom, P. Eng.

THE APPLICANT HAS BEEN CAUTIONED AS TO THE FOLLOWING:

15.21 INFORMATION TO USER.

The users manual or instruction manual for an intentional radiator shall caution the user that changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

15.27(a) SPECIAL ACCESSORIES.

Equipment marketed to a consumer must be capable of complying with the necessary regulations in the configuration in which the equipment is marketed. Where special accessories, such as shielded cables and/or special connectors are required to enable an unintentional or intentional radiator to comply with the emission limits in this part, the equipment must be marketed with, i.e. shipped and sold with, those special accessories. However, in lieu of shipping or packaging the special accessories with the unintentional or intentional radiator, the responsible party may employ other methods of ensuring that the special accessories are provided to the consumer, without additional charge.

Information detailing any alternative method used to supply the special accessories for a grant of equipment authorization or retained in the verification records, as appropriate. The party responsible for the equipment, as detailed in § 2.909 of this chapter, shall ensure that these special accessories are provided with the equipment. The instruction manual for such devices shall include appropriate instructions on the first page of text concerned with the installation of the device that these special accessories must be used with the device. It is the responsibility of the user to use the needed special accessories supplied with the equipment.

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Required information per ISO/IEC Guide 25-1990, paragraph 13.2:

a) TEST REPORT

- b) Laboratory: M. Flom Associates, Inc.
(FCC: 31040/SIT) 3356 N. San Marcos Place, Suite 107
(Canada: IC 2044) Chandler, AZ 85225
- c) Report Number: d0230007
- d) Client: Nokia Corporation
Elektroniikkatie 10
Fin-90570
Oulu, Finland
- e) Identification: FCC ID: LJPNC-1
Description: Single Band, Dual Mode Cellular Telephone
- f) EUT Condition: Not required unless specified in individual tests.
- g) Report Date: March 8, 2002
EUT Received: March 4, 2002
- h, j, k): As indicated in individual tests.
- i) Sampling method: No sampling procedure used.
- l) Uncertainty: In accordance with MFA internal quality manual.
- m) Supervised by:
- 
Morton Flom, P. Eng.
- n) Results: The results presented in this report relate only to the item tested.
- o) Reproduction: This report must not be reproduced, except in full, without written permission from this laboratory.

ACCESSORIES USED DURING TESTING:

Type	Model	S/N	Specimen ID
EUT	LJPNC-1	23514034616	s00318
Standard NiMH Battery	BMC-2	N/A	s00319
Extended Li-Ion Battery	BLC-2	N/A	s00320
Extended NiMH Battery	BMC-3	N/A	s00321
Standard Travel Charger	ACP-7U	N/A	s01248
Rapid Travel Charger	ACP-8U	N/A	s01250
Rapid Travel Charger	ACP-9U	N/A	s01249
Rapid Travel Charger	ACP-12U	N/A	s01275
Headset	HDE-5	N/A	s00322
Headset	HDE-2	N/A	s00323

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LIST OF GENERAL INFORMATION REQUIRED FOR CERTIFICATIONIN ACCORDANCE WITH FCC RULES AND REGULATIONS,
VOLUME II, PART 2 AND TO

22H, 22.901(d), Confidentiality

Sub-part 2.1033

(c)(1): NAME AND ADDRESS OF APPLICANT:Nokia Corporation
Elektroniikkatie 10
Fin-90570
Oulu, FinlandMANUFACTURERS:Nokia Manufacturing Inc U.S.A.
5650 Alliance Gateway
Fort Worth, TX 76155Nokia TMC., Ltd.
Yangduck-Dong 973-6
Hwe won-Ku, Masan. KoreaNokia Mexico, S.A. DE C.V.
Ave. Ind. Rio Bravo s/n, Parque
Ind. Del Nte.
Cd. Reynosa, Tam. CP 88730Nokia Brazil Manaus AM
Rod. Torquato Tapajós, 7200 KM
12 - Tarumã
Postal code: 69048-660
Manaus, Amazonas, Brazil(c)(2): FCC ID: LJPNC-1(c)(3): INSTRUCTION MANUAL(S):

PLEASE SEE ATTACHED EXHIBITS

(c)(4): TYPE OF EMISSION: 40K0F1D, 40K0F8W, 30K0DXW(c)(5): FREQUENCY RANGE, MHz: 824.04 to 893.97(c)(6): POWER RATING, Watts: 0.211 ERP AMPS
0.399 ERP TDMA
 Switchable x Variable N/A

FCC GRANT NOTE:

BC - The output power is
continuously variable from
the value listed above to
5%-10% of the value listed.(c)(7): MAXIMUM POWER RATING, Watts: 7 Watts

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Subpart 2.1033 (continued)

(c)(8): VOLTAGES & CURRENTS IN ALL ELEMENTS IN FINAL R. F. STAGE,
INCLUDING FINAL TRANSISTOR OR SOLID STATE DEVICE:

COLLECTOR CURRENT, A = per manual
COLLECTOR VOLTAGE, Vdc = per manual
SUPPLY VOLTAGE, Vdc = 3.9

(c)(9): TUNE-UP PROCEDURE:

PLEASE SEE ATTACHED EXHIBITS

(c)(10): CIRCUIT DIAGRAM/CIRCUIT DESCRIPTION:

Including description of circuitry & devices provided for
determining and stabilizing frequency, for suppression of
spurious radiation, for limiting modulation and limiting
power.

PLEASE SEE ATTACHED EXHIBITS

(c)(11): LABEL INFORMATION:

PLEASE SEE ATTACHED EXHIBITS

(c)(12): PHOTOGRAPHS:

PLEASE SEE ATTACHED EXHIBITS

(c)(13): DIGITAL MODULATION DESCRIPTION:

 ATTACHED EXHIBITS
 X N/A

(c)(14): TEST AND MEASUREMENT DATA:

FOLLOWS

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M. Flom Associates, Inc. is accredited by the American Association for Laboratory Accreditation (A2LA) as shown in the scope below.

 THE AMERICAN ASSOCIATION FOR LABORATORY ACCREDITATION ACCREDITED LABORATORY A2LA has accredited M. FLOM ASSOCIATES, INC. Chandler, AZ for technical competence in the field of Electrical (EMC) Testing The accreditation covers the specific tests and types of tests listed on the agreed scope of accreditation. This laboratory meets the requirements of ISO/IEC 17025 - 1999 "General Requirements for the Competence of Testing and Calibration Laboratories" and any additional program requirements in the identified field of testing. Testing and calibration laboratories that comply with this International Standard also operate in accordance with ISO 9001 or ISO 9002. Presented this 2nd day of March, 2001.  Peter M. Mays President For the Accreditation Council Certificate Number 1008.01 Valid to December 31, 2002 For tests or types of tests to which this accreditation applies, please refer to the laboratory's Electrical (EMC) Scope of Accreditation	 American Association for Laboratory Accreditation <u>SCOPE OF ACCREDITATION TO ISO/IEC 17025:1999</u> M. FLOM ASSOCIATES, INC. Electronic Testing Laboratory 3356 North San Marcos Place, Suite 107 Chandler, AZ 85223 Morton Flom Phone: 480 926 3100 ELECTRICAL (EMC) Valid to: December 31, 2002 Certificate Number: 1008-01 In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following <u>electromagnetic compatibility tests</u>: <table border="0"> <thead> <tr> <th>Tests</th> <th>Standard(s)</th> </tr> </thead> <tbody> <tr> <td>RF Emissions</td> <td>FCC Part 15 (Subparts B and C) using ANSI C63.4-1992; CISPR 11; CISPR 13; CISPR 14; CISPR 22; EN 55011; EN 55013; EN 55014; EN 55022; EN 50081-1; EN 50081-2; ICES-003; AS/NZS 1044; AS/NZS 1053; AS/NZS 3548; AS/NZS 4251.1; CNS 13438</td> </tr> <tr> <td>Harmonic Currents</td> <td>EN 61000-3-2</td> </tr> <tr> <td>Fluctuation and Flicker</td> <td>EN 61000-3-3</td> </tr> <tr> <td>RF Immunity</td> <td>EN: 50082-1, 50082-2 (both excluding "Power Frequency Magnetic Field Immunity" and "Voltage Dips, Short Interruptions, and Line Voltage Variations"); AS/NZS 4251.1</td> </tr> <tr> <td>Radiated Susceptibility</td> <td>EN 61000-4-3; ENV 50140; ENV 50204; IEC 1000-4-3; IEC 801-3</td> </tr> <tr> <td>EFT</td> <td>EN 61000-4-4; IEC 1000-4-4; IEC 801-4</td> </tr> <tr> <td>Surge</td> <td>EN 61000-4-5; ENV 50142; IEC 1000-4-5; IEC 801-5</td> </tr> <tr> <td>47 CFR (FCC)</td> <td>2, 21, 22, 23, 24, 74, 80, 87, 90, 95, 97</td> </tr> </tbody> </table>  5301 Buckeystown Pike, Suite 350 • Frederick, MD 21704-8373 • Phone: 301-644 3248 • Fax: 301-662 2974	Tests	Standard(s)	RF Emissions	FCC Part 15 (Subparts B and C) using ANSI C63.4-1992; CISPR 11; CISPR 13; CISPR 14; CISPR 22; EN 55011; EN 55013; EN 55014; EN 55022; EN 50081-1; EN 50081-2; ICES-003; AS/NZS 1044; AS/NZS 1053; AS/NZS 3548; AS/NZS 4251.1; CNS 13438	Harmonic Currents	EN 61000-3-2	Fluctuation and Flicker	EN 61000-3-3	RF Immunity	EN: 50082-1, 50082-2 (both excluding "Power Frequency Magnetic Field Immunity" and "Voltage Dips, Short Interruptions, and Line Voltage Variations"); AS/NZS 4251.1	Radiated Susceptibility	EN 61000-4-3; ENV 50140; ENV 50204; IEC 1000-4-3; IEC 801-3	EFT	EN 61000-4-4; IEC 1000-4-4; IEC 801-4	Surge	EN 61000-4-5; ENV 50142; IEC 1000-4-5; IEC 801-5	47 CFR (FCC)	2, 21, 22, 23, 24, 74, 80, 87, 90, 95, 97
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RF Emissions	FCC Part 15 (Subparts B and C) using ANSI C63.4-1992; CISPR 11; CISPR 13; CISPR 14; CISPR 22; EN 55011; EN 55013; EN 55014; EN 55022; EN 50081-1; EN 50081-2; ICES-003; AS/NZS 1044; AS/NZS 1053; AS/NZS 3548; AS/NZS 4251.1; CNS 13438																		
Harmonic Currents	EN 61000-3-2																		
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EFT	EN 61000-4-4; IEC 1000-4-4; IEC 801-4																		
Surge	EN 61000-4-5; ENV 50142; IEC 1000-4-5; IEC 801-5																		
47 CFR (FCC)	2, 21, 22, 23, 24, 74, 80, 87, 90, 95, 97																		

"This laboratory is accredited by the American Association for Laboratory Accreditation (A2LA) and the results shown in this report have been determined in accordance with the laboratory's terms of accreditation unless stated otherwise in the report."

Should this report contain any data for tests for which we are not accredited, or which have been undertaken by a subcontractor that is not A2LA accredited, such data would not covered by this laboratory's A2LA accreditation.

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Sub-part

2.1033(c)(14):

TEST AND MEASUREMENT DATA

All tests and measurement data shown were performed in accordance with FCC Rules and Regulations, Volume II; Part 2, Sub-part J, Sections 2.947, 2.1033(c), 2.1041, 2.1046, 2.1047, 2.1079, 2.1051, 2.1053, 2.1055, 2.1057 and the following individual Parts:

- ☐ 21 - Domestic Public Fixed Radio Services
- ☐ 22 - Public Mobile Services
- ☒ 22 Subpart H - Cellular Radiotelephone Service
- ☒ 22.901(d) - Alternative technologies and auxiliary services
- ☐ 23 - International Fixed Public Radiocommunication services
- ☐ 24 - Personal Communications Services
- ☐ 74 Subpart H - Low Power Auxiliary Stations
- ☐ 80 - Stations in the Maritime Services
- ☐ 80 Subpart E - General Technical Standards
- ☐ 80 Subpart F - Equipment Authorization for Compulsory Ships
- ☐ 80 Subpart K - Private Coast Stations and Marine Utility Stations
- ☐ 80 Subpart S - Compulsory Radiotelephone Installations for Small Passenger Boats
- ☐ 80 Subpart T - Radiotelephone Installation Required for Vessels on the Great Lakes
- ☐ 80 Subpart U - Radiotelephone Installations Required by the Bridge-to-Bridge Act
- ☐ 80 Subpart V - Emergency Position Indicating Radiobeacons (EPIRB'S)
- ☐ 80 Subpart W - Global Maritime Distress and Safety System (GMDSS)
- ☐ 80 Subpart X - Voluntary Radio Installations
- ☐ 87 - Aviation Services
- ☐ 90 - Private Land Mobile Radio Services
- ☐ 94 - Private Operational-Fixed Microwave Service
- ☐ 95 Subpart A - General Mobile Radio Service (GMRS)
- ☐ 95 Subpart C - Radio Control (R/C) Radio Service
- ☐ 95 Subpart D - Citizens Band (CB) Radio Service
- ☐ 95 Subpart E - Family Radio Service
- ☐ 95 Subpart F - Interactive Video and Data Service (IVDS)
- ☐ 97 - Amateur Radio Service
- ☐ 101 - Fixed Microwave Services

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GENERAL INFORMATION

1. Prior to testing, the deviation for audio modulation and each of the respective SAT + ST tones were set as close as possible to the required limit.
2. Except for audio modulation, which was applied externally, Wideband Data SAT, ST and all other tones and operational modes were provided by a test control unit incorporating appropriate software. Worst case repetition rate for Wideband Data was 10 kb/s.
3. Spurious radiation was measured at three (3) meters.
4. The two cellular frequency bands are available to the user automatically. Please refer to the manual contained in the documentation.
5. The normal modes of modulation are:
 - ☒ (a) VOICE
 - ☒ (b) WIDEBAND DATA
 - ☒ (c) SAT
 - ☒ (d) ST
 - ☒ (e) SAT + VOICE
 - ☒ (f) SAT + DTMF
 - ☐ (g) CDMA
 - ☒ (h) TDMA
 - ☐ (i) NAMPS VOICE
 - ☐ (j) NAMPS DSAT
 - ☐ (k) NAMPS ST
 - ☐ (l) NAMPS VOICE + DSAT

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STANDARD TEST CONDITIONS
and
ENGINEERING PRACTICES

Except as noted herein, the following conditions and procedures were observed during the testing:

In accordance with ANSI C63.4-1992/2000 Draft, section 6.1.9, and unless otherwise indicated in the specific measurement results, the ambient temperature of the actual EUT was maintained within the range of 10° to 40°C (50° to 104 °F) unless the particular equipment requirements specify testing over a different temperature range. Also, unless otherwise indicated, the humidity levels were in the range of 10% to 90% relative humidity.

Prior to testing, the EUT was tuned up in accordance with the manufacturer's alignment procedures. All external gain controls were maintained at the position of maximum and/or optimum gain throughout the testing.

Measurement results, unless otherwise noted, are worst case measurements.

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NAME OF TEST: Carrier Output Power (Conducted)

SPECIFICATION: 47 CFR 2.1046(a)

TEST EQUIPMENT: As per attached page

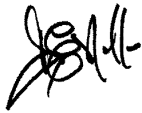
MEASUREMENT PROCEDURE

1. The EUT was connected to a resistive coaxial attenuator of normal load impedance, and the unmodulated output power was measured by means of an R. F. Power Meter.
2. Measurement accuracy is $\pm 3\%$.

MEASUREMENT RESULTS

NOMINAL, MHz	CHANNEL	dBm		R. F. POWER, WATTS	
		Lo	Hi	Lo	Hi
AMPS MODE:					
824.040	991	5.8	24.8	3.84 mW	0.304
836.400	380	5.9	24.8	3.92 mW	0.300
848.970	799	5.0	24.7	3.14 mW	0.294
TDMA MODE:					
824.040	991	-4.4	27.5	360 μ W	0.568
836.400	380	-4.1	27.5	395 μ W	0.563
848.970	799	-5.2	27.3	302 μ W	0.540

PERFORMED BY:

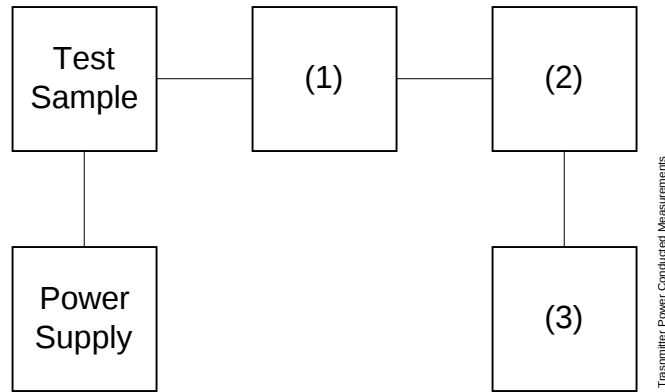

Doug Noble, B.A.S. E.E.T.

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TRANSMITTER POWER CONDUCTED MEASUREMENTS

TEST 1: R. F. POWER OUTPUT
 TEST 2: FREQUENCY STABILITY



Asset	Description (as applicable)	s/n
(1)	<u>COAXIAL ATTENUATOR</u>	
i00122	Narda 766-10	7802
i00123	Narda 766-10	7802A
i00069	Bird 8329 (30 dB)	1006
i00113	Sierra 661A-3D	1059
(2)	<u>POWER METERS</u>	
i00014	HP 435A	1733A05836
i00039	HP 436A	2709A26776
i00020	HP 8901A POWER MODE	2105A01087
(3)	<u>FREQUENCY COUNTER</u>	
i00042	HP 5383A	1628A00959
i00019	HP 5334B	2704A00347
i00020	HP 8901A FREQUENCY MODE	2105A01087

PAGE NO.

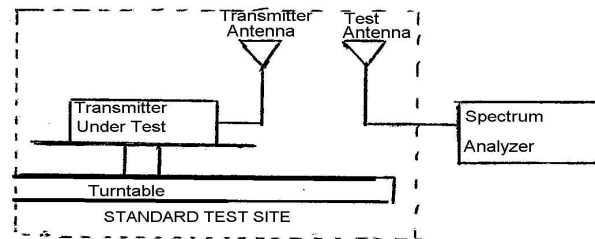
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NAME OF TEST: Radiated Power Output (Substitution Method)

Definition: The average radiated power of device is the equivalent power required, when delivered to a substitution antenna, to produce at a distant point the same average received power as produced by the licensed device.

Method of Measurement:

a) Connect the equipment as illustrated. Place the transmitter to be tested on the turntable in the standard test site.



b) Raise and lower the test antenna from 1m to 4m and rotate turntable from 0° to 360°. Record the highest received signal in dB as E_T .

c) Replace the transmitter under test with a substitution antenna. The center of the antenna should be at the same location as the transmitter under test. Connect the antenna to a signal generator with a known output power level using the same modulation as with the transmitter. Raise and lower the test antenna like in step b) and record the highest received signal in dB as E_S .

d) Calculate radiated power as following:

Radiated power = Level + E_T - E_S + Gain_{Ant}

E_T Signal level received from transmitter
 E_S Signal level received from substitution antenna

	Freq MHz	Level dBm	Gain _{Ant}	$E_T - E_S$ dB	Power dBm	Power Watts
AMPS	824.04	3.0	-5.21dBd	24.5	22.3 ERP	0.169 ERP
	836.40	3.0	-5.29dBd	25.5	23.2 ERP	0.209 ERP
	848.97	2.9	-5.35dBd	25.7	23.3 ERP	0.211 ERP
TDMA	824.04	5.7	-5.21dBd	25.4	25.9 ERP	0.388 ERP
	836.40	5.7	-5.29dBd	25.6	26.0 ERP	0.399 ERP
	848.97	5.5	-5.35dBd	25.0	25.2 ERP	0.327 ERP

Description	s/n
TRANSDUCER	
Seibersdorf PBA10200 precision biconical	327/00

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NAME OF TEST: Audio Frequency Response
SPECIFICATION: 47 CFR 2.1047(a)
TEST EQUIPMENT: As per previous page

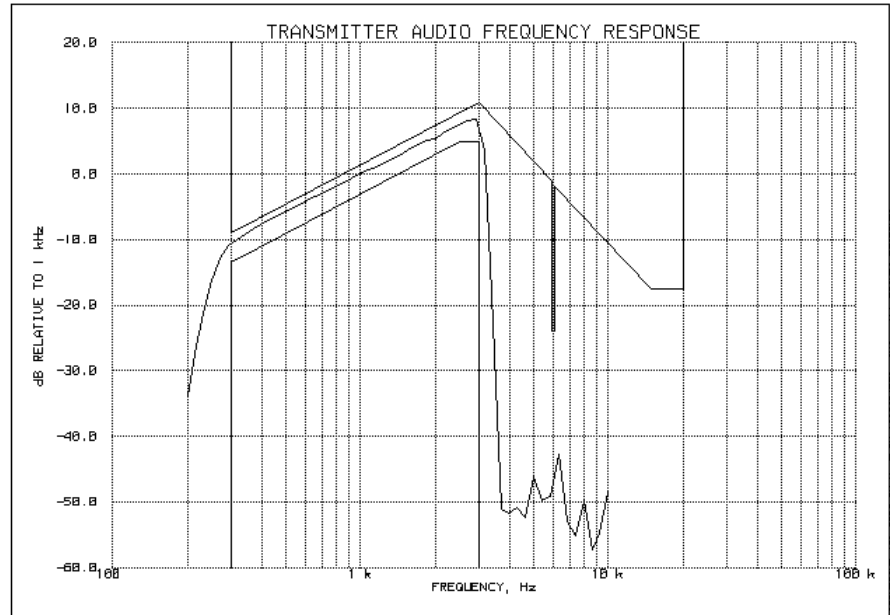
MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page.
2. The audio signal generator was connected to the audio input circuit/microphone of the EUT.
3. The audio signal input was adjusted to obtain 20% modulation at 1 kHz, and this point was taken as the 0 dB reference level.
4. With input levels held constant and below limiting at all frequencies, the audio signal generator was varied from 100 Hz to 50 kHz.
5. The response in dB relative to 1 kHz was then measured, using the HP 8901A Modulation Analyzer.
6. MEASUREMENT RESULTS: ATTACHED

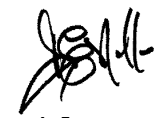
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NAME OF TEST: Audio Frequency Response
g0230038: 2002-Mar-06 Wed 14:15:00
STATE: 0:General



PERFORMED BY:


Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Audio Low Pass Filter (Voice Input)
SPECIFICATION: 47 CFR 2.1047(a)
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

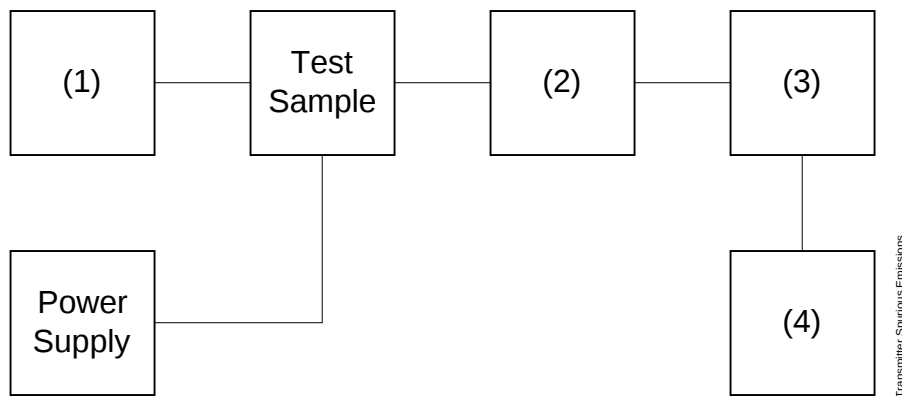
1. The EUT and test equipment were set up such that the audio input was connected at the input to the modulation limiter, and the modulated stage.
2. The audio output was connected at the output to the modulated stage.
3. MEASUREMENT RESULTS: ATTACHED

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TRANSMITTER SPURIOUS EMISSION

TEST A. OCCUPIED BANDWIDTH (IN-BAND SPURIOUS)
 TEST B. OUT-OF-BAND SPURIOUS

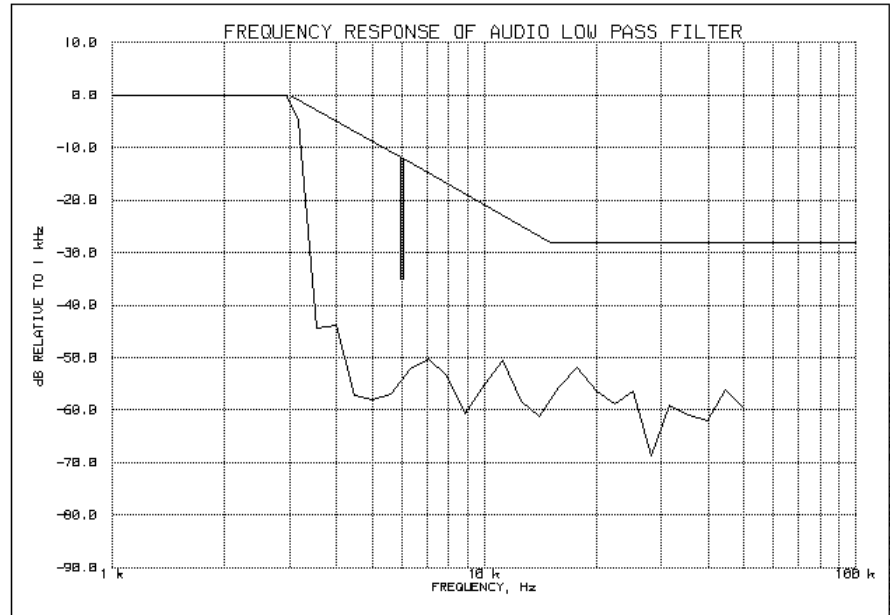


Asset Description (as applicable)	s/n
(1) <u>AUDIO OSCILLATOR/GENERATOR</u>	
i00010 HP 204D	1105A04683
i00017 HP 8903A	2216A01753
i00012 HP 3312A	1432A11250
(2) <u>COAXIAL ATTENUATOR</u>	
i00122 Narda 766-10	7802
i00123 Narda 766-10	7802A
i00069 Bird 8329 (30 dB)	1006
i00113 Sierra 661A-3D	1059
(3) <u>FILTERS; NOTCH, HP, LP, BP</u>	
i00126 Eagle TNF-1	100-250
i00125 Eagle TNF-1	50-60
i00124 Eagle TNF-1	250-850
(4) <u>SPECTRUM ANALYZER</u>	
i00048 HP 8566B	2511A01467
i00029 HP 8563E	3213A00104

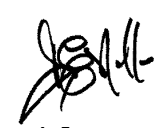
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NAME OF TEST: Audio Low Pass Filter (Voice Input)
g0230039: 2002-Mar-06 Wed 14:21:00
STATE: 0:General



PERFORMED BY:


Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Modulation Limiting

SPECIFICATION: 47 CFR 2.1047(b)

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The audio signal generator was connected to the audio input circuit/microphone of the EUT as for Frequency Response of the Audio Modulating Circuit.
2. The modulation response was measured for each of three tones (one of which was the frequency of maximum response), and the input voltage was varied and was observed on an HP 8901A Modulation Analyzer.
3. The audio input level was varied from 30% modulation (± 3.6 kHz deviation) to at least 20 dB higher than the saturation point.
4. Measurements were performed for both negative and positive modulation and the respective results were recorded.
5. MEASUREMENT RESULTS ATTACHED FOR:

COMPANDER ON:

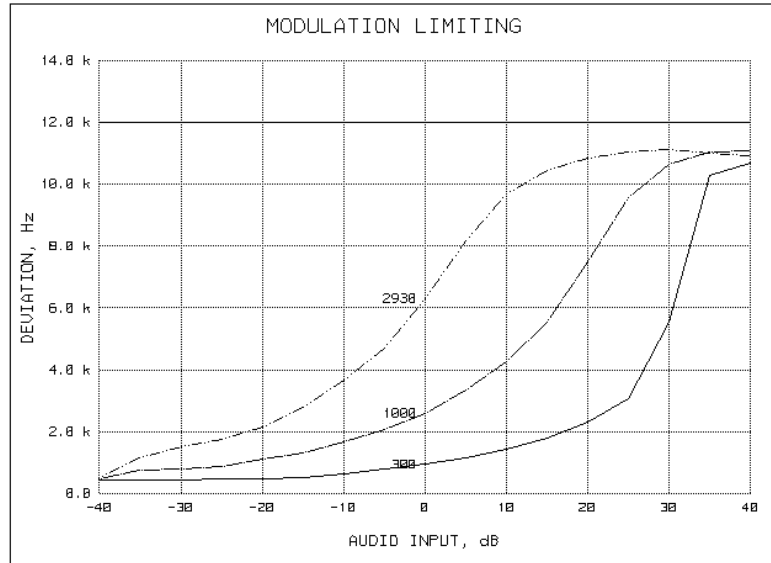
x VOICE
x VOICE + SAT

PAGE NO.

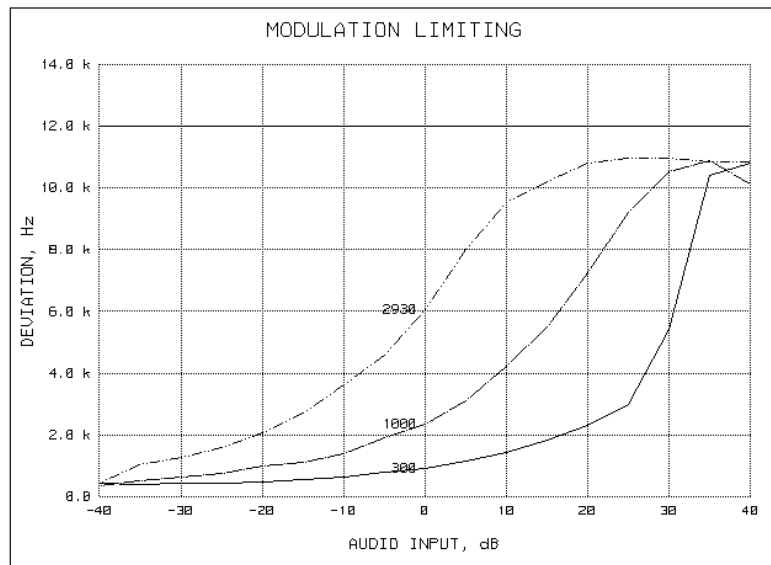
17 of 72.

NAME OF TEST: Modulation Limiting
 g0230030: 2002-Mar-06 Wed 12:51:00
 STATE: 0:General VOICE ONLY

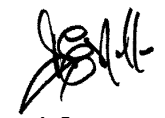
Positive
 Peaks:



Negative
 Peaks:



PERFORMED BY:

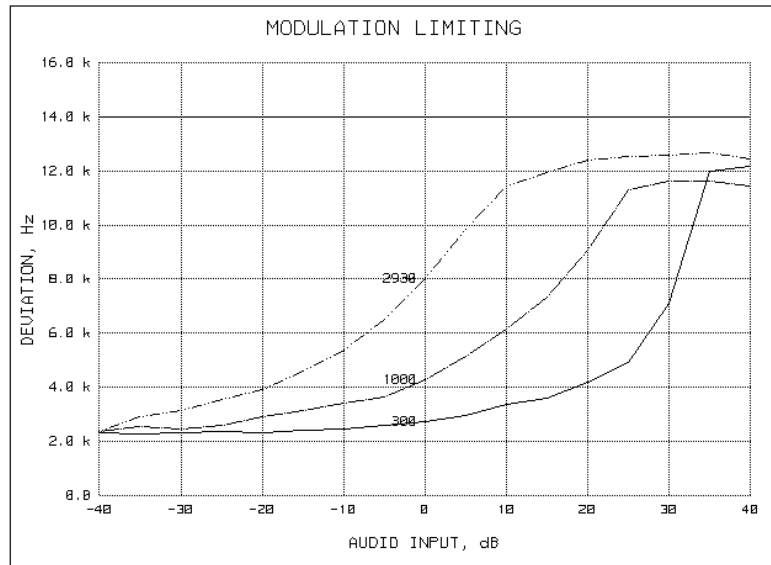

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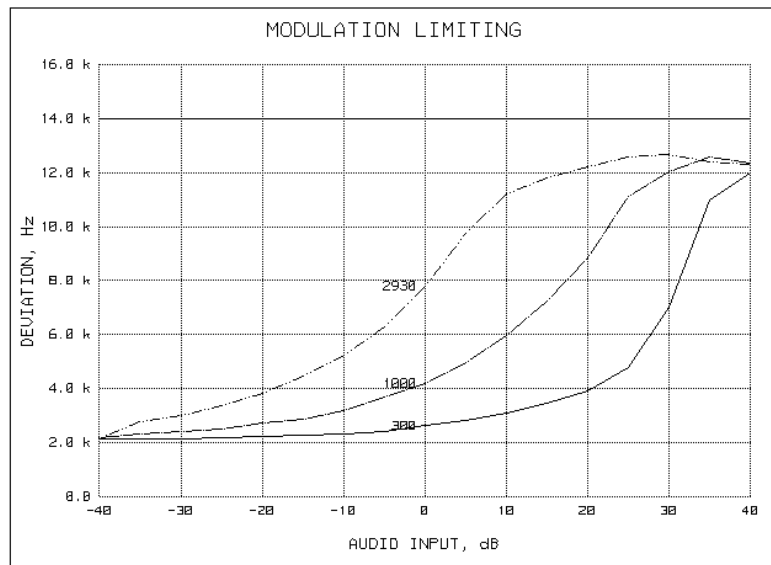
18 of 72.

NAME OF TEST: Modulation Limiting
 g0230031: 2002-Mar-06 Wed 12:56:00
 STATE: 0:General VOICE + SAT

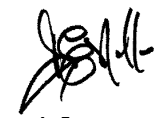
Positive
 Peaks:



Negative
 Peaks:



PERFORMED BY:


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NAME OF TEST: Measurement Of Maximum Deviation

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

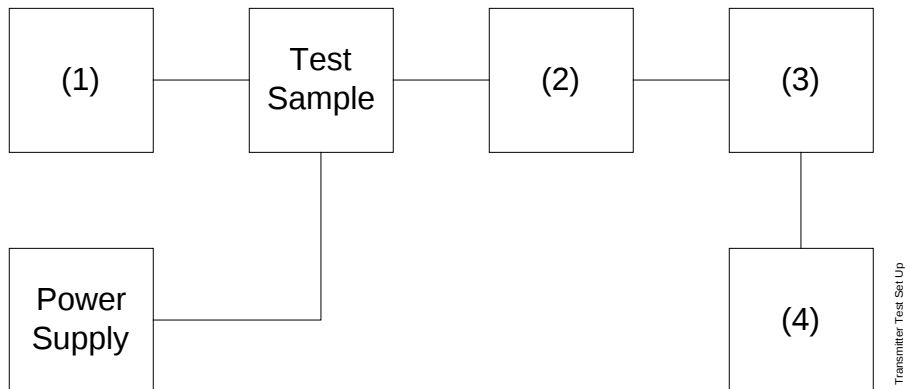
1. The presentation of tones was obtained by attaching the HP 8903A Oscilloscope to the Modulation Output of the HP 8901 Modulation Analyzer.
2. The EUT was modulated by an HP 8903 Audio Analyzer and/or internally generated signals.
3. Maximum deviation measurements were recorded for the various configurations.
4. MEASUREMENT RESULTS: ATTACHED SUMMARY FOR DEVIATION

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TRANSMITTER TEST SET-UP

TEST A. MODULATION CAPABILITY/DISTORTION
 TEST B. AUDIO FREQUENCY RESPONSE
 TEST C. HUM AND NOISE LEVEL
 TEST D. RESPONSE OF LOW PASS FILTER
 TEST E. MODULATION LIMITING



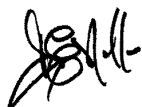
Asset Description (as applicable)	s/n
(1) <u>Audio Oscillator</u>	
i00010 HP 204D	1105A04683
i00017 HP 8903A	2216A01753
i00118 HP 33120A	US36002064
(2) <u>COAXIAL ATTENUATOR</u>	
i00122 NARDA 766-10	7802
i00123 NARDA 766-10	7802A
i00113 SIERRA 661A-3D	1059
i00069 BIRD 8329 (30 dB)	10066
(3) <u>MODULATION ANALYZER</u>	
i00020 HP 8901A	2105A01087
(4) <u>AUDIO ANALYZER</u>	
i00017 HP 8903A	2216A01753

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MEASUREMENT SUMMARY: Measurement Of Maximum Deviation

MODULATION	LIMIT, kHz	DEVIATION, MHz
(a) Voice	$\geq 10.8 \text{ \& } \leq 13.2$	10.8
(b) Wideband Data	$\geq 7.2 \text{ \& } \leq 8.8$	8.0
(c) SAT	$\geq 1.8 \text{ \& } \leq 2.2$	2.1
(d) ST	$\geq 7.2 \text{ \& } \leq 8.8$	8.0
(e) SAT + VOICE	N/A	11.0
(f) SAT + DTMF	N/A	10.8
(i) NAMPS VOICE	N/A	N/A
(j) NAMPS DSAT	N/A	N/A
(k) NAMPS ST	N/A	N/A
(l) NAMPS VOICE	N/A	N/A

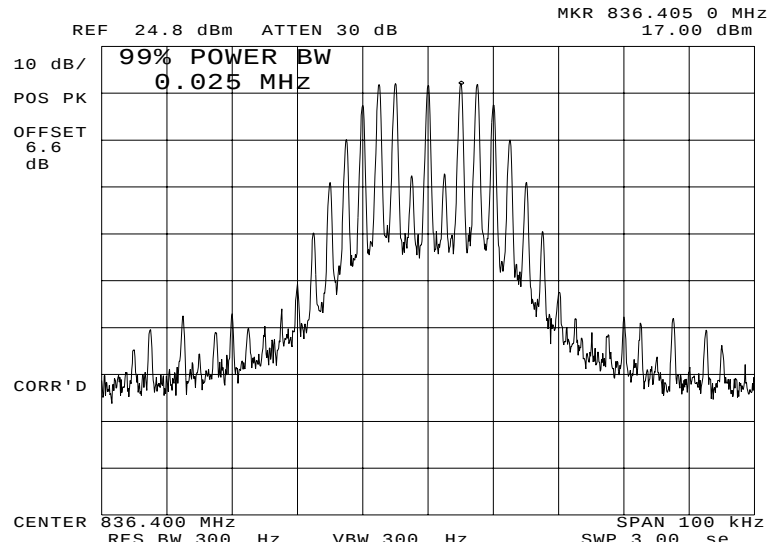
PERFORMED BY:


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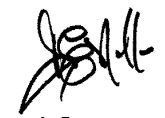
NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230177: 2002-Mar-08 Fri 10:29:00
STATE: 2:High Power



POWER:
MODULATION:

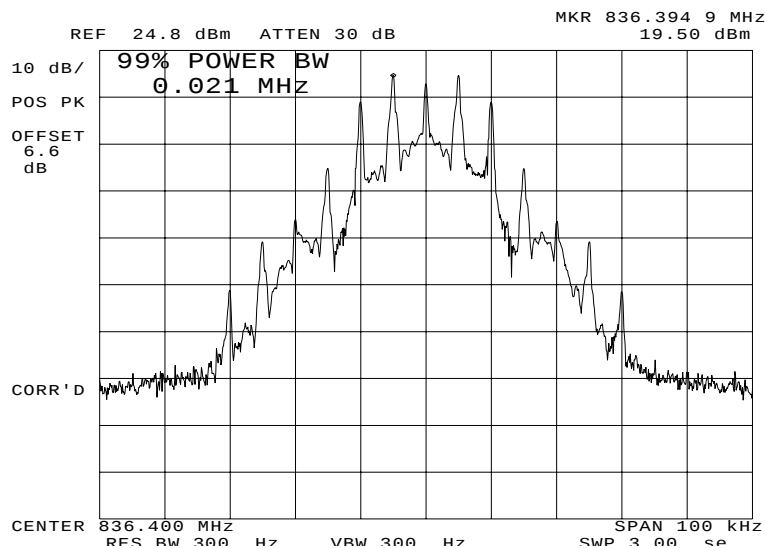
HIGH
VOICE: 2500 HZ SINE WAVE
AMPS
99 % POWER BANDWIDTH

PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230179: 2002-Mar-08 Fri 10:34:00
 STATE: 2:High Power



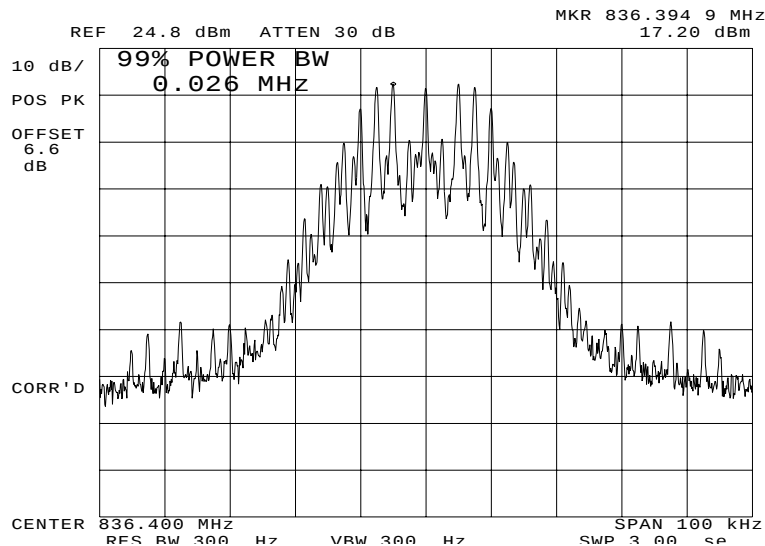
POWER: HIGH
 MODULATION: WBD AMPS
 99 % POWER BANDWIDTH

PERFORMED BY:

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230180: 2002-Mar-08 Fri 10:36:00
STATE: 2:High Power



POWER: HIGH
MODULATION: SAT+VOICE AMPS
99 % POWER BANDWIDTH

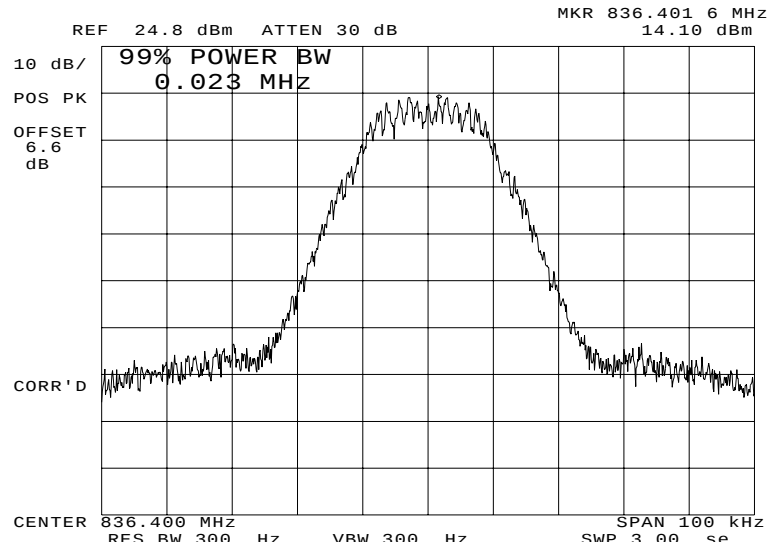
PERFORMED BY:

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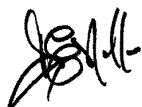
NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230178: 2002-Mar-08 Fri 10:32:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 SAT+DTMF AMPS
 99 % POWER BANDWIDTH

PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
SPECIFICATION: 47 CFR 2.1049(c)(1), 22
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page, with the Spectrum Analyzer connected.
2. For EUTs supporting audio modulation, the audio signal generator was adjusted to the frequency of maximum response and with output level set for ± 2.5 kHz deviation (or 50% modulation). With level constant, the signal level was increased 16 dB.
3. For EUTs supporting digital modulation, the digital modulation mode was operated to its maximum extent.
4. The Occupied Bandwidth was measured with the Spectrum Analyzer controls set as shown on the test results.
5. MEASUREMENT RESULTS: ATTACHED

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MEASUREMENT SUMMARY: Emission Masks (Occupied Bandwidth)

MODULATION	MEASURED DEVIATION ±kHz (HP 8901A)	LIMIT ±kHz	B/W @-26 dB PLOTS, kHz
NONE	0.0	0.0	0.0
VOICE	10.8	≥ 10.8 & ≤ 13.2	25
WIDEBAND DATA	8.0	≥ 7.2 & ≤ 8.8	21
SAT + VOICE	11.0	N/A	26
SAT + DTMF	10.8	N/A	23
CDMA	N/A	N/A	N/A
TDMA	N/A	N/A	28
NAMPS	N/A	N/A	N/A

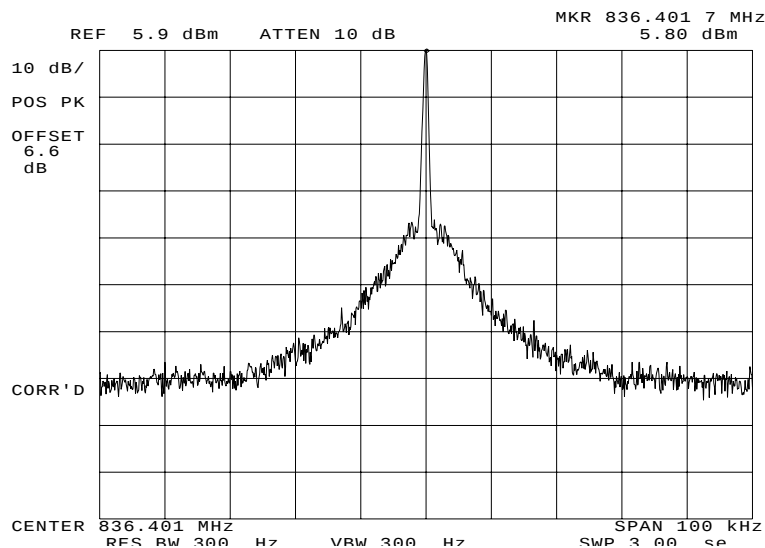
PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230135: 2002-Mar-06 Wed 14:42:00
STATE: 1:Low Power



POWER:

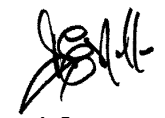
MODULATION:

LOW

NONE

AMPS

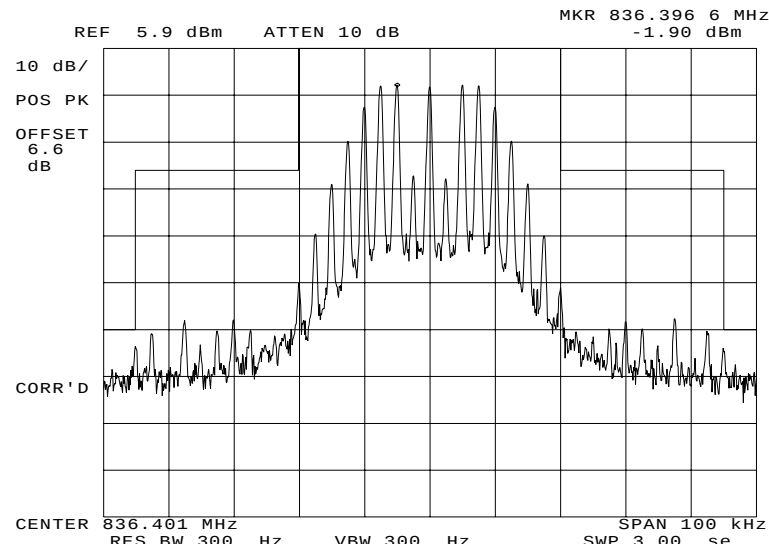
PERFORMED BY:


Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230136: 2002-Mar-06 Wed 14:46:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 VOICE: 2500 Hz SINE WAVE
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

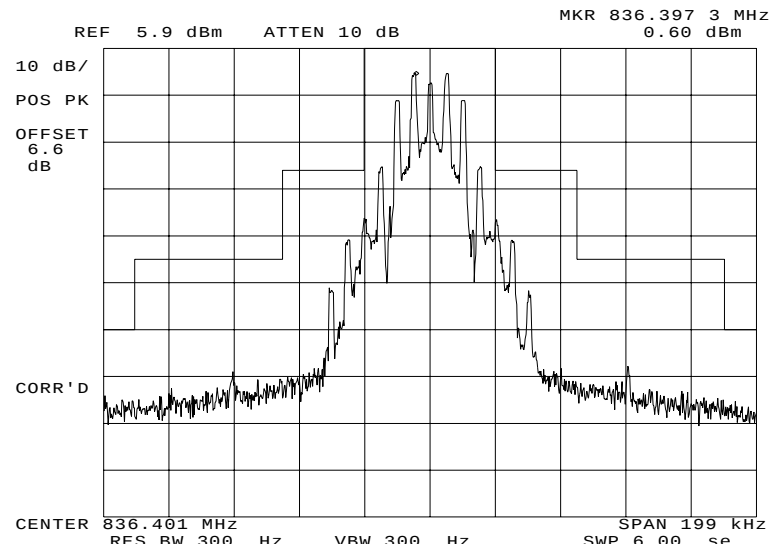
PERFORMED BY:


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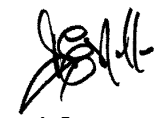
NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230139: 2002-Mar-06 Wed 14:52:00
STATE: 1:Low Power



POWER:
MODULATION:

LOW
WBD
MASK: AMPS CELLULAR, F1D,
DATA

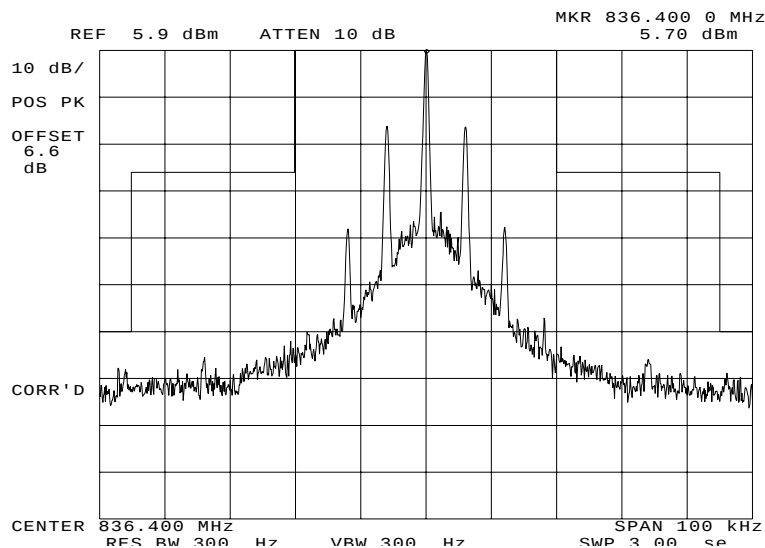
PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230140: 2002-Mar-06 Wed 15:00:00
STATE: 1:Low Power



POWER:

MODULATION:

LOW

SAT

MASK: AMPS CELLULAR,
F3E/F3D w/LPF

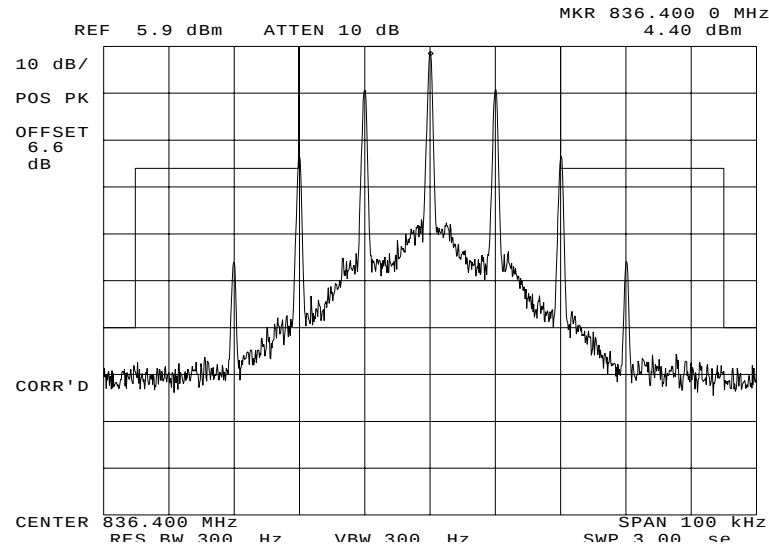
PERFORMED BY:

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230143: 2002-Mar-06 Wed 15:07:00
 STATE: 1:Low Power



POWER:

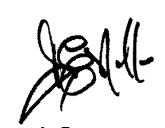
MODULATION:

LOW

ST

MASK: AMPS CELLULAR,
F3E/F3D w/LPF

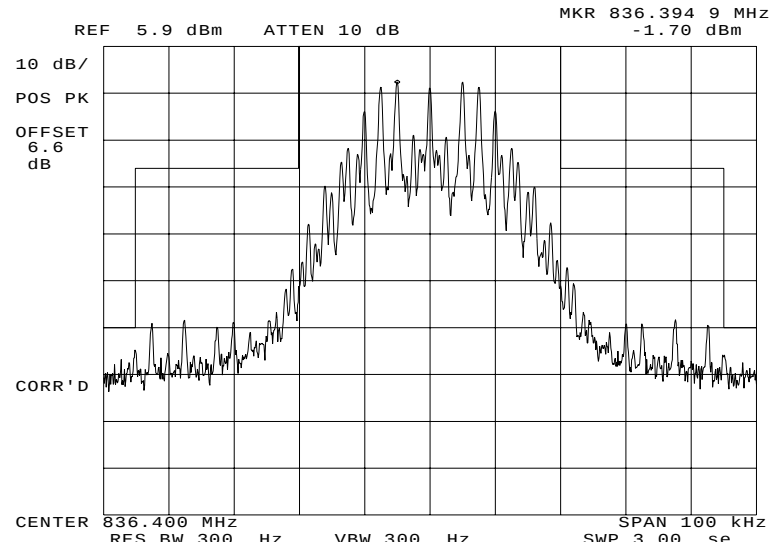
PERFORMED BY:


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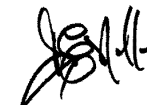
NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230144: 2002-Mar-06 Wed 15:09:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 SAT+VOICE
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

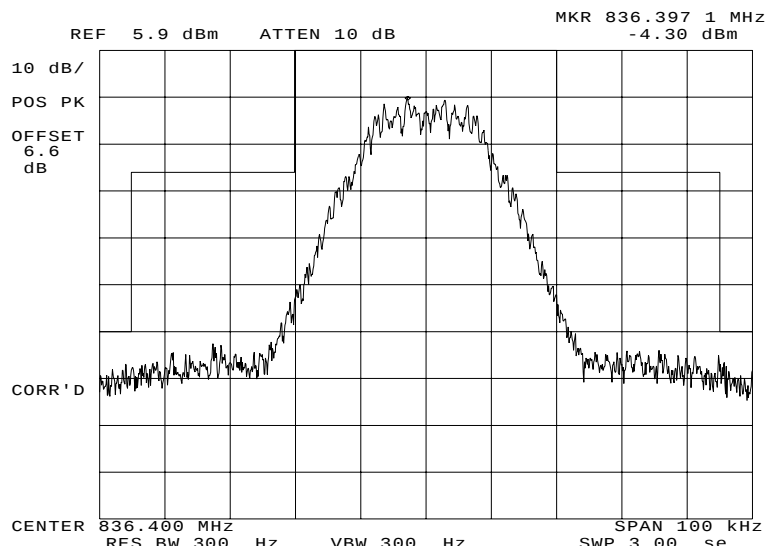
PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230147: 2002-Mar-06 Wed 15:13:00
 STATE: 1:Low Power



POWER:

MODULATION:

LOW

SAT+DTMF

MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

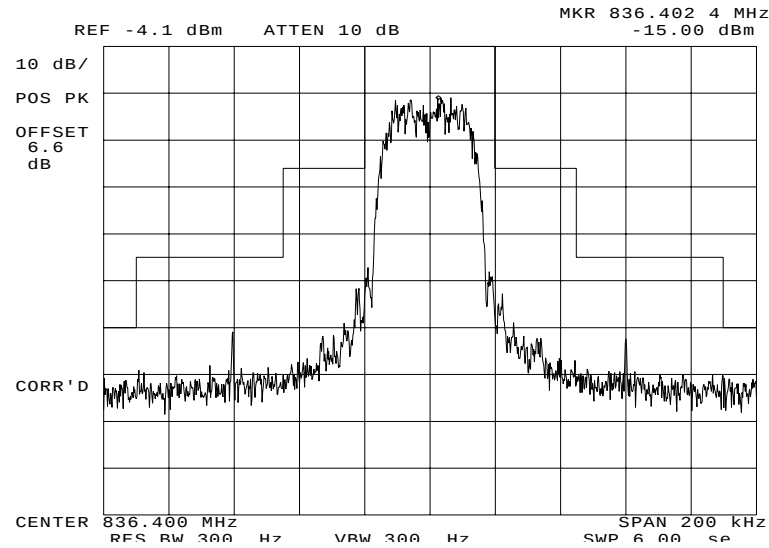
PERFORMED BY:

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230158: 2002-Mar-07 Thu 09:34:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 DQPSK TDMA CELLULAR
 MASK: AMPS CELLULAR, F1D,
 DATA

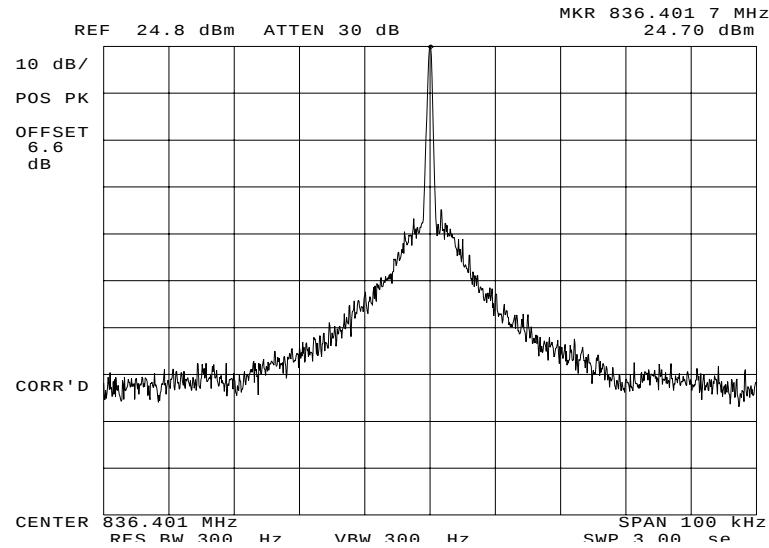
PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230134: 2002-Mar-06 Wed 14:40:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
NONE
AMPS

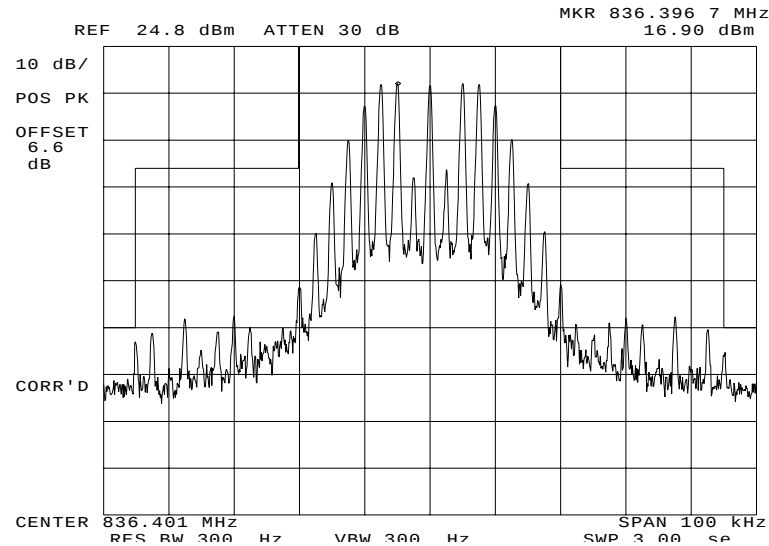
PERFORMED BY:


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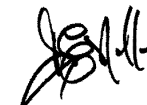
NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230137: 2002-Mar-06 Wed 14:47:00
 STATE: 2:High Power



POWER:
MODULATION:

HIGH
VOICE: 2500 Hz SINE WAVE
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

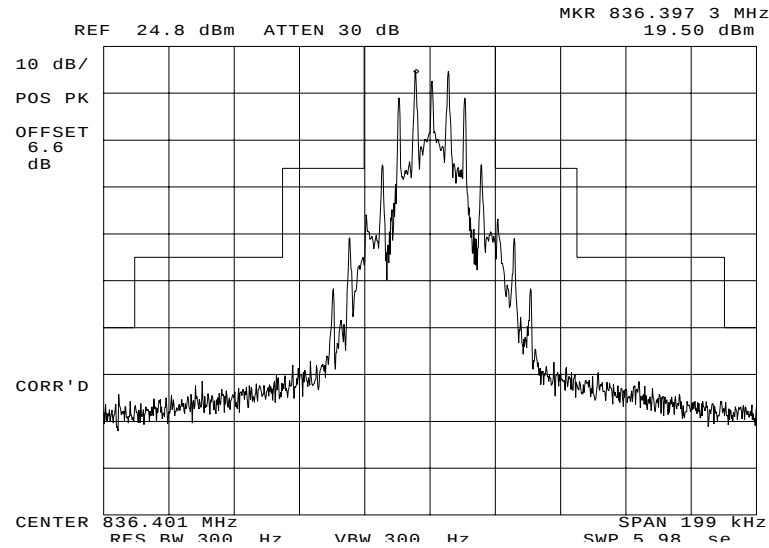
PERFORMED BY:


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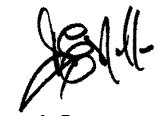
NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230138: 2002-Mar-06 Wed 14:50:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
WBD
MASK: AMPS CELLULAR, F1D,
DATA

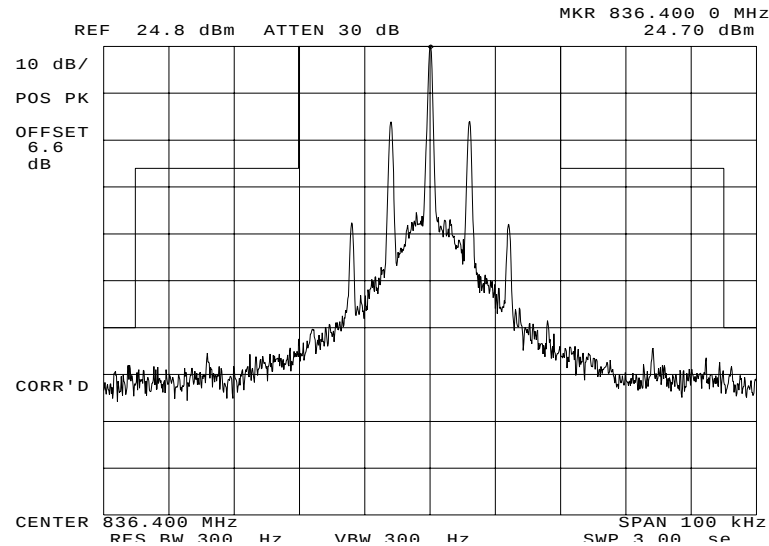
PERFORMED BY:


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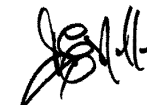
NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230141: 2002-Mar-06 Wed 15:01:00
 STATE: 2:High Power



POWER:
MODULATION:

HIGH
SAT
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

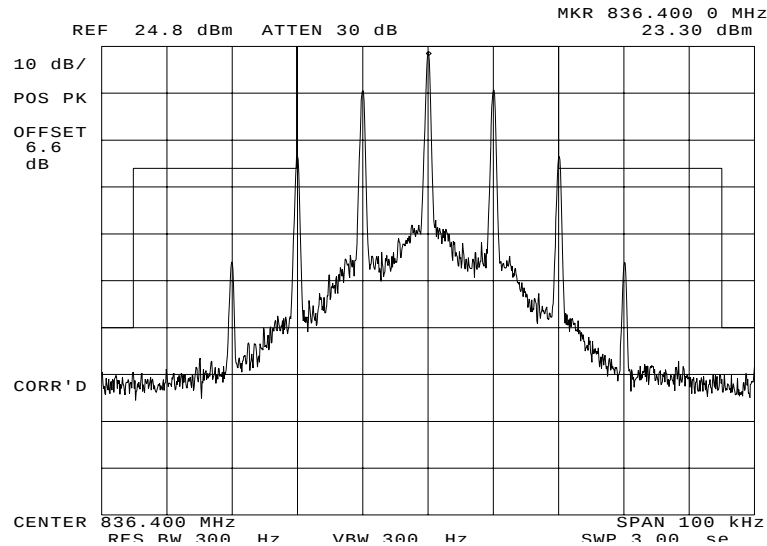
PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230142: 2002-Mar-06 Wed 15:06:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
ST
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

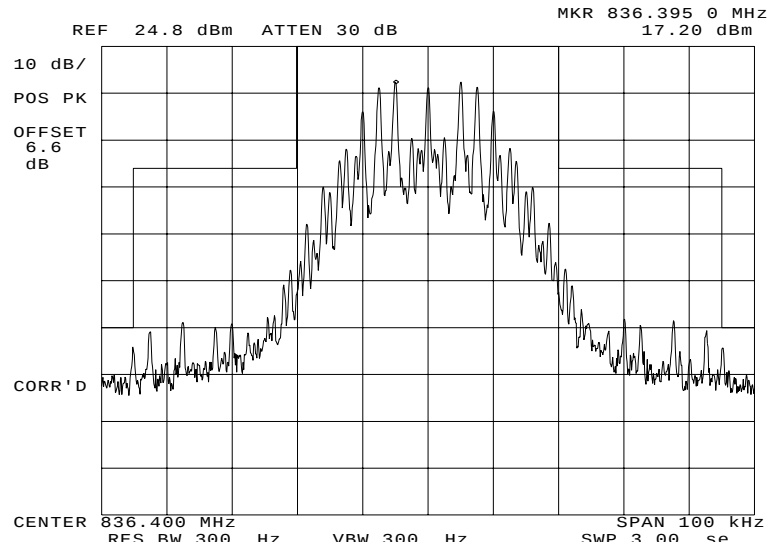
PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230145: 2002-Mar-06 Wed 15:09:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
SAT+VOICE
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

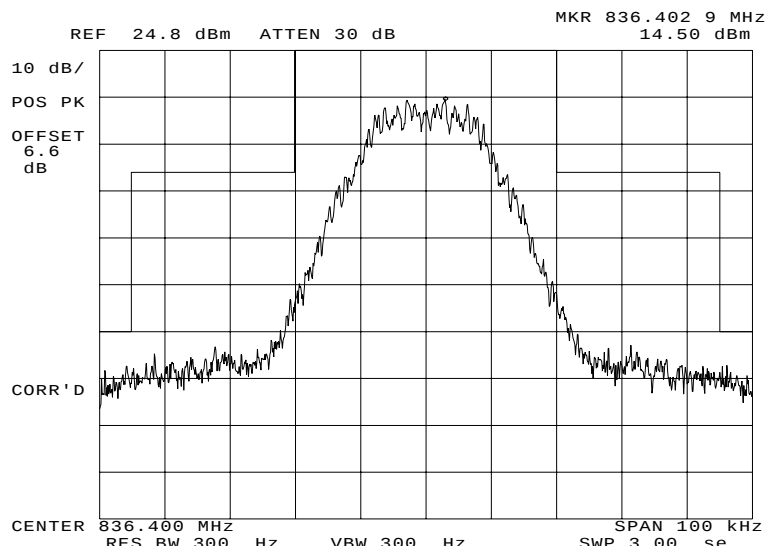
PERFORMED BY:


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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230146: 2002-Mar-06 Wed 15:12:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 SAT+DTMF
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

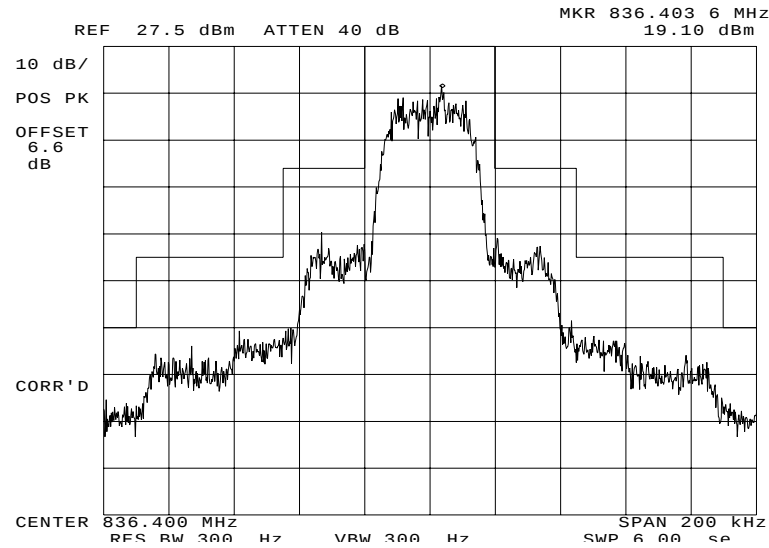
PERFORMED BY:

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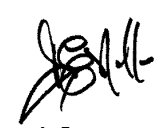
NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230157: 2002-Mar-07 Thu 09:31:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 DQPSK TDMA CELLULAR
 MASK: AMPS CELLULAR, F1D,
 DATA

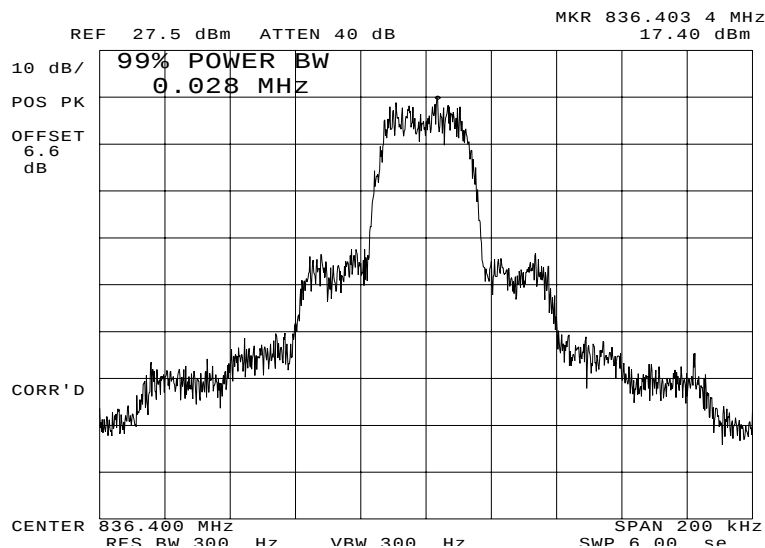
PERFORMED BY:


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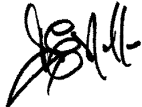
NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230159: 2002-Mar-07 Thu 09:36:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
DQPSK TDMA CELLULAR
99 % POWER BANDWIDTH

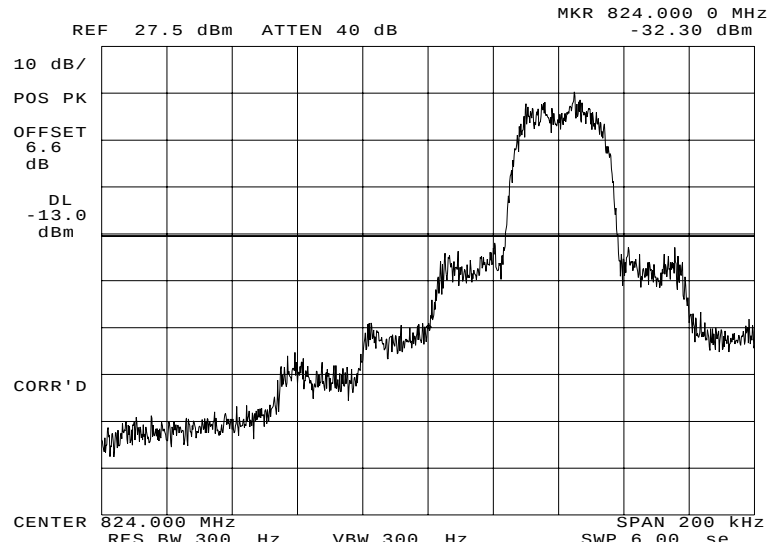
PERFORMED BY:


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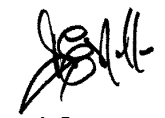
NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230160: 2002-Mar-07 Thu 09:45:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
DQPSK TDMA CELLULAR
LOWER BANDEDGE CH 991

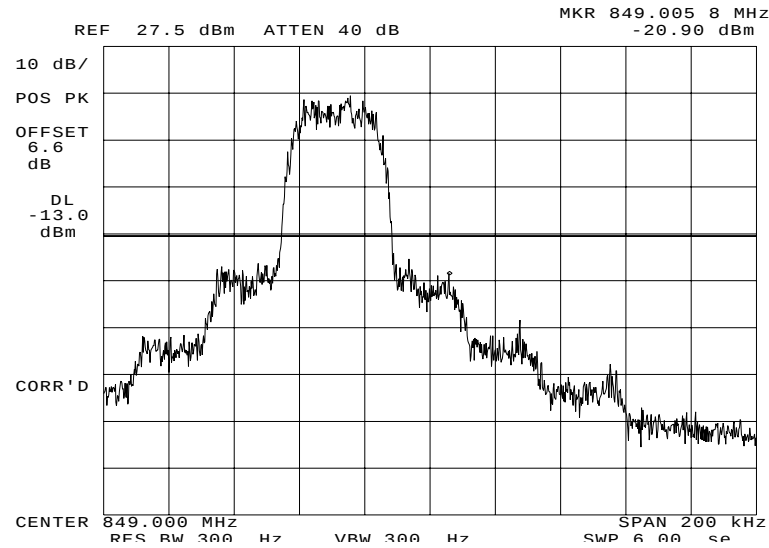
PERFORMED BY:


Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230161: 2002-Mar-07 Thu 10:00:00
 STATE: 2:High Power



POWER:
 MODULATION:

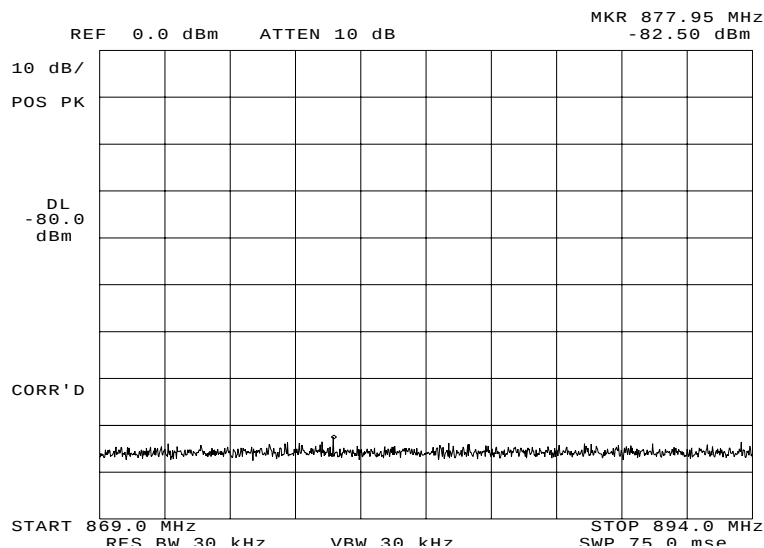
HIGH
 DQPSK TDMA CELLULAR
 UPPER BANDEDGE CH 799

PERFORMED BY:


 Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230163: 2002-Mar-07 Thu 12:51:00
 STATE: 1:Low Power



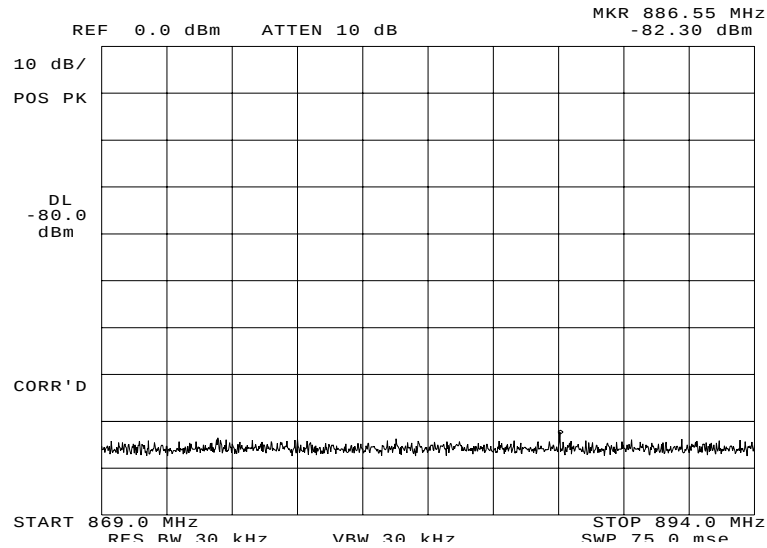
POWER: LOW
 MODULATION: DQPSK TDMA CELLULAR
 TX SPURS IN RX CRITICAL BAND

PERFORMED BY: Doug Noble, B.A.S. E.E.T.

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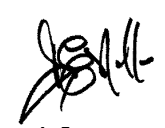
NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230162: 2002-Mar-07 Thu 12:50:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 DQPSK TDMA CELLULAR
 TX SPURS IN RX CRITICAL
 BAND

PERFORMED BY:


 Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Requirements -
Worst Case Modulation & Wideband Data

SPECIFICATION: 47 CFR 22.917

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT was connected to a coaxial attenuator and then to a spectrum analyzer. The unmodulated carrier was set for 0 dB reference level.
2. A notch filter was introduced to reduce or eliminate any spectrum analyzer internally generated spurious for measurements of the harmonics and the carrier level.
3. Spectrum analyzer bandwidth was set to section 22.917(h) as applicable.
4. Measurements were made on channels 380, 799 and 991. The equipment was first modulated for the Worst Case Modulation, then for Wideband Data (F8W, F1D).
5. All other spurious emissions over the range of 0 the beyond the 10th harmonic (10 GHz) were 20 dB or more below the limit
6. The data presented here is for the Worst Case.
7. MEASUREMENT RESULTS: ATTACHED

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MEASUREMENT SUMMARY: Emission Requirements -
Worst Case Modulation

WORST CASE MODULATION = VOICE +_SAT

EMISSION, MHz/HARM.	LIMIT, dBc	SPURIOUS EMISSIONS, dBc	
		Lo	Hi
F0 + 20 kHz To F0 + 45 kHz	≤ -26	≤ -52	≤ -48
F0 + 45 kHz To 2 nd Harmonic	≤ -60 or $43 + 10 \log P$	≤ -69	≤ -71
2 nd to 10 th	$(\leq -13 \text{ dBm})$	≤ -69	≤ -71

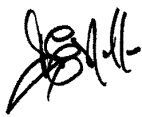
MEASUREMENT RESULTS = ATTACHED OFFSET PLOTS

EMISSION IN THE RECEIVER CRITICAL BAND

EMISSION, MHz/HARM.	LIMIT, dBm	SPURIOUS EMISSIONS, dBm	
		Lo	Hi
869 to 894	≤ -80	≤ -82	≤ -83

MEASUREMENT RESULTS = ATTACHED PLOTS

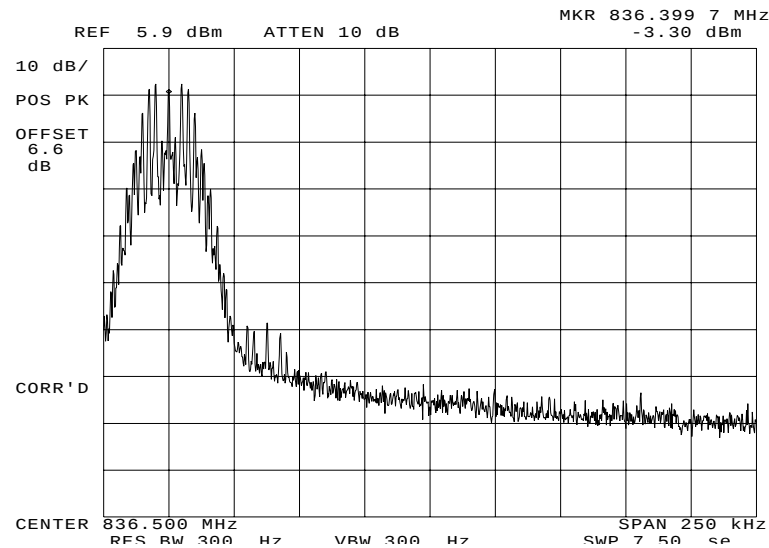
PERFORMED BY:


Doug Noble, B.A.S. E.E.T.

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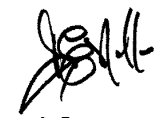
NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230148: 2002-Mar-06 Wed 15:16:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 SAT+VOICE
 OFFSET OCCUPIED BANDWIDTH

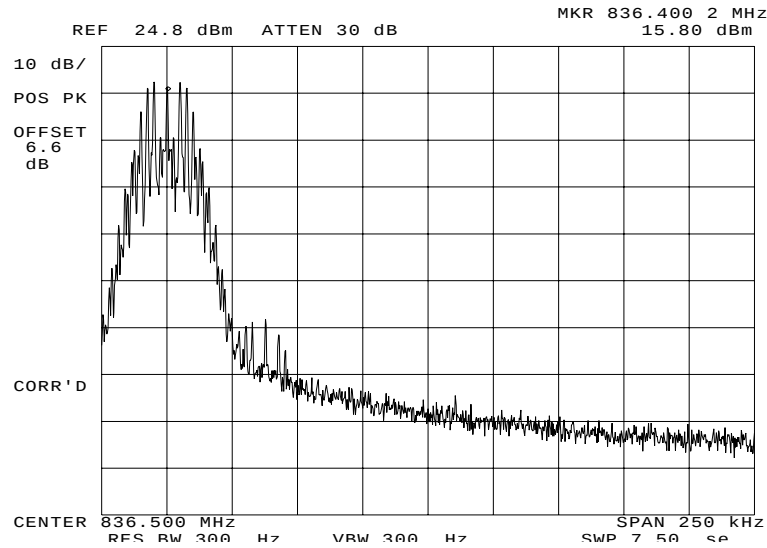
PERFORMED BY:


 Doug Noble, B.A.S. E.E.T.

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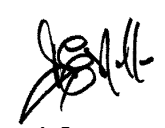
NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230150: 2002-Mar-07 Thu 08:22:00
 STATE: 2:High Power



POWER:
 MODULATION:

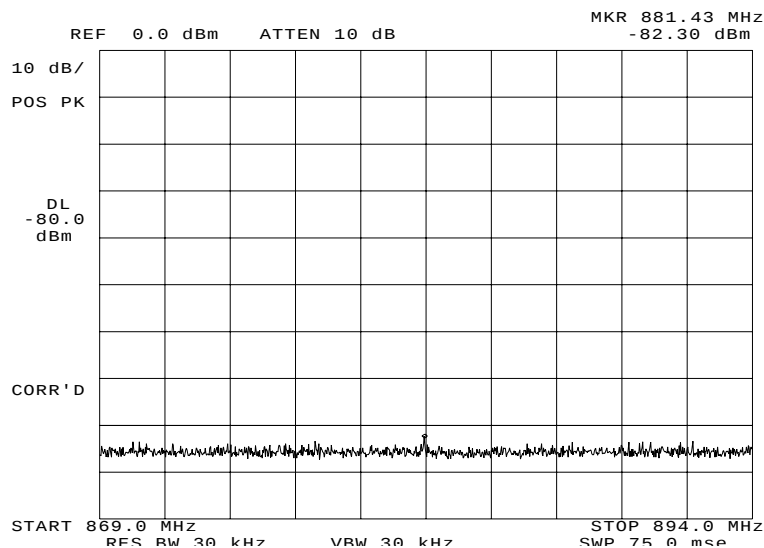
HIGH
 SAT+VOICE
 OFFSET OCCUPIED BANDWIDTH

PERFORMED BY:


 Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230152: 2002-Mar-07 Thu 08:26:00
 STATE: 1:Low Power



POWER:
 MODULATION:

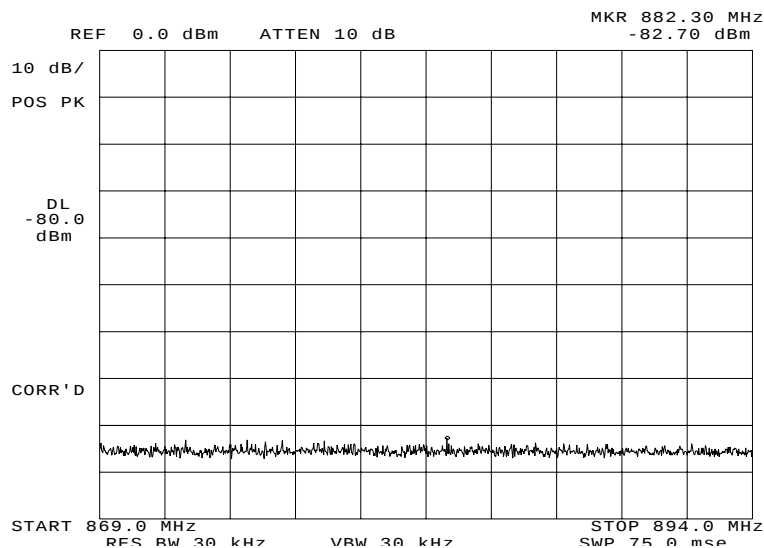
LOW
 VOICE 2500 HZ AMPS CELLULAR
 TX SPURS IN RX CRITICAL
 BAND

PERFORMED BY:


 Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230151: 2002-Mar-07 Thu 08:25:00
 STATE: 2:High Power



POWER: HIGH
 MODULATION: VOICE 2500 HZ AMPS CELLULAR
 TX SPURS IN RX CRITICAL
 BAND

PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

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MEASUREMENT SUMMARY: Emission Requirements -
Wideband Data (F1D, 10 kb/s)

EMISSION, MHz/HARM.	LIMIT, dBc	SPURIOUS EMISSIONS, dBc	
		Lo	Hi
F0 + 20 kHz to F0 + 45 kHz	≤ -26	≤ -41	≤ -42
F0 + 45 kHz to F0 + 90 kHz	≤ -45	≤ -69	≤ -71
F0 + 90 kHz to 2 nd Harmonic	≤ -60 (≤ -13 dBm)	≤ -69	≤ -71
2 nd to 10 th	(≤ -13 dBm)	≤ -69	≤ -71

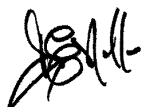
MEASUREMENT RESULTS = ATTACHED OFFSET PLOTS

EMISSION IN THE RECEIVER CRITICAL BAND

EMISSION, MHz/HARM.	LIMIT, dBm	SPURIOUS EMISSIONS, dBm	
		Lo	Hi
869 to 894	≤ -80	≤ -82	≤ -83

MEASUREMENT RESULTS = ATTACHED PLOTS

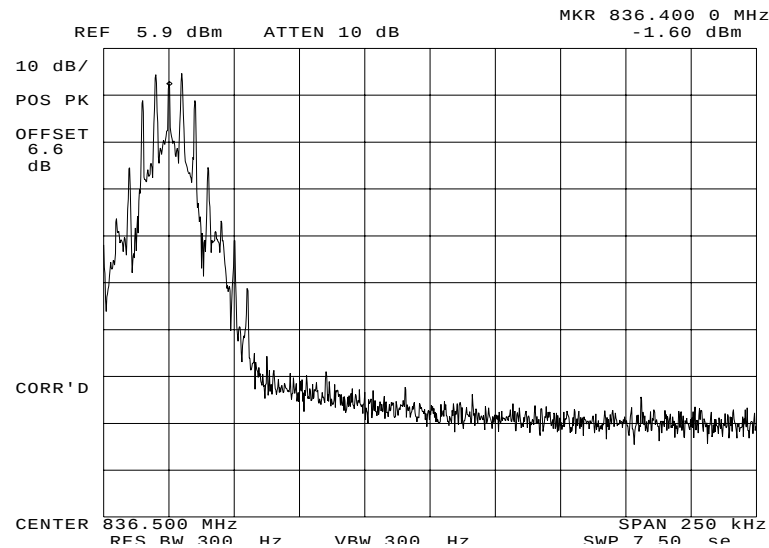
PERFORMED BY:


 Doug Noble, B.A.S. E.E.T.

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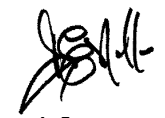
NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230153: 2002-Mar-07 Thu 08:29:00
STATE: 1:Low Power



POWER:
MODULATION:

LOW
WBD AMPS
OFFSET OCCUPIED BANDWIDTH

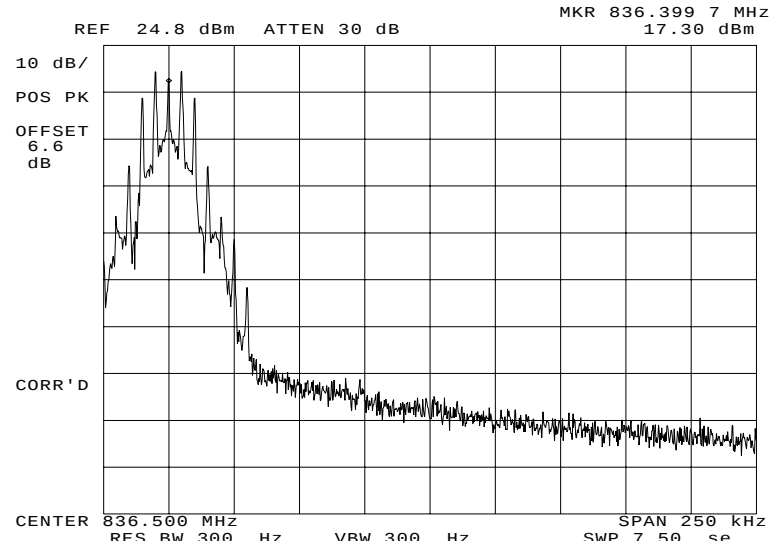
PERFORMED BY:


Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0230155: 2002-Mar-07 Thu 09:23:00
STATE: 2:High Power



POWER:
MODULATION:

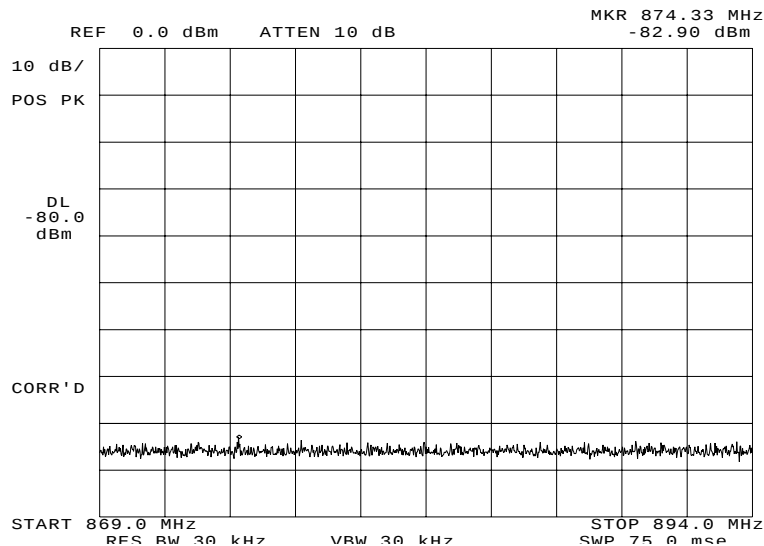
HIGH
WBD AMPS
OFFSET OCCUPIED BANDWIDTH

PERFORMED BY:


Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230154: 2002-Mar-07 Thu 08:30:00
 STATE: 1:Low Power

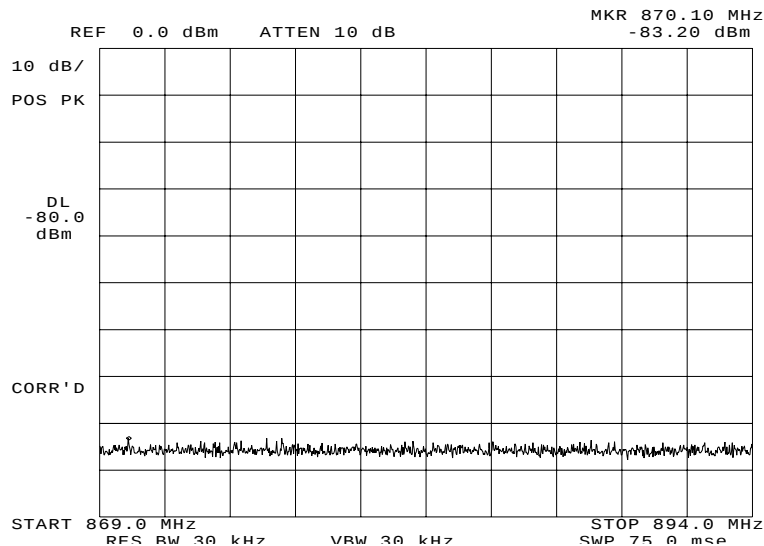


POWER: LOW
 MODULATION: WBD AMPS
 TX SPURS IN RX CRITICAL BAND

PERFORMED BY: Doug Noble, B.A.S. E.E.T.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0230156: 2002-Mar-07 Thu 09:25:00
 STATE: 2:High Power



POWER: HIGH
 MODULATION: WBD AMPS
 TX SPURS IN RX CRITICAL BAND

PERFORMED BY: Doug Noble, B.A.S. E.E.T.

PAGE NO. 60 of 72.
NAME OF TEST: Spurious Emissions at Antenna Terminals
SPECIFICATION: 47 CFR 2.1051, 22.917
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was connected to a coaxial attenuator and then to a Spectrum Analyzer.
2. A notch filter was introduced to reduce or eliminate spurious emission which could be generated internally in the spectrum analyzer.
3. Measurements were made over the range from 45 kHz to 10 GHz for the worst case modulation so both the highest and lowest R.F. power settings.
4. All other emissions were 20 dB or more below the limit.
5. Spectrum analyzer bandwidth was set to section 22.917(h) as applicable.
6. MEASUREMENT RESULTS: ATTACHED

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0230168: 2002-Mar-07 Thu 14:27:00
 STATE: 1:Low Power Amps

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
824.040000	1648.050000	-51.5	-57.4	-38.5
836.400000	1672.790500	-55.4	-61.3	-42.4
848.970000	1697.930000	-57.4	-63.3	-44.4
824.040000	2472.114500	-51.4	-57.3	-38.4
836.400000	2509.205000	-77.7	-83.6	-64.7
848.970000	2546.935000	-77.9	-83.8	-64.9
824.040000	3296.285600	-79.9	-85.8	-66.9
836.400000	3345.439900	-78.8	-84.7	-65.8
848.970000	3395.818000	-79.3	-85.2	-66.3
824.040000	4120.008300	-79.5	-85.4	-66.5
836.400000	4181.826400	-78.9	-84.8	-65.9
848.970000	4244.886000	-79.8	-85.7	-66.8
824.040000	4944.353600	-79.3	-85.2	-66.3
836.400000	5018.399500	-79.2	-85.1	-66.2
848.970000	5093.754900	-78.7	-84.6	-65.7
824.040000	5768.153400	-79.5	-85.4	-66.5
836.400000	5854.661900	-73.5	-79.4	-60.5
848.970000	5942.961100	-73.2	-79.1	-60.2
824.040000	6592.262500	-73.8	-79.7	-60.8
836.400000	6691.198500	-73.7	-79.6	-60.7
848.970000	6791.563800	-73.3	-79.2	-60.3
824.040000	7416.602700	-73.4	-79.3	-60.4
836.400000	7527.374800	-73	-78.9	-60
848.970000	7640.872100	-73.6	-79.5	-60.6
824.040000	8240.317400	-73	-78.9	-60
836.400000	8363.770300	-73.2	-79.1	-60.2
848.970000	8489.878600	-74	-79.9	-61
824.040000	9064.305400	-73.8	-79.7	-60.8
836.400000	9200.490100	-73.3	-79.2	-60.3
848.970000	9338.438800	-74	-79.9	-61
824.040000	9888.353400	-74.1	-80	-61.1
836.400000	10036.614400	-72.6	-78.5	-59.6
848.970000	10187.861200	-73.9	-79.8	-60.9
824.040000	10712.363400	-73	-78.9	-60
836.400000	10873.403700	-71	-76.9	-58
848.970000	11036.753100	-72.4	-78.3	-59.4
824.040000	11536.344300	-71.1	-77	-58.1
836.400000	11709.526900	-71.8	-77.7	-58.8
848.970000	11885.829700	-72.4	-78.3	-59.4
824.040000	12360.434900	-72.4	-78.3	-59.4
836.400000	12546.079700	-68.6	-74.5	-55.6
848.970000	12734.754800	-68	-73.9	-55

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0230167: 2002-Mar-07 Thu 14:20:00
 STATE: 2:High Power AMPS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
824.040000	1648.070000	-41.9	-66.7	-28.9
836.400000	1672.798000	-37.7	-62.5	-24.7
848.970000	1697.932500	-39.9	-64.7	-26.9
824.040000	2472.106000	-40.1	-64.9	-27.1
836.400000	2509.178000	-55	-79.8	-42
848.970000	2546.888500	-52.7	-77.5	-39.7
824.040000	3296.117000	-59.5	-84.3	-46.5
836.400000	3345.757600	-59.1	-83.9	-46.1
848.970000	3395.779400	-59.8	-84.6	-46.8
824.040000	4120.201500	-59.2	-84	-46.2
836.400000	4181.960000	-58	-82.8	-45
848.970000	4245.043700	-59	-83.8	-46
824.040000	4944.417100	-59.4	-84.2	-46.4
836.400000	5018.405000	-59.1	-83.9	-46.1
848.970000	5093.884100	-59.2	-84	-46.2
824.040000	5768.249500	-59.5	-84.3	-46.5
836.400000	5854.904100	-53.7	-78.5	-40.7
848.970000	5942.974100	-52.3	-77.1	-39.3
824.040000	6592.270000	-53.4	-78.2	-40.4
836.400000	6691.299100	-51.8	-76.6	-38.8
848.970000	6791.845600	-53.2	-78	-40.2
824.040000	7416.606700	-53.8	-78.6	-40.8
836.400000	7527.850200	-53.9	-78.7	-40.9
848.970000	7640.520800	-53	-77.8	-40
824.040000	8240.541600	-53.4	-78.2	-40.4
836.400000	8363.916900	-53	-77.8	-40
848.970000	8489.454300	-54.1	-78.9	-41.1
824.040000	9064.651700	-53.7	-78.5	-40.7
836.400000	9200.625200	-53.4	-78.2	-40.4
848.970000	9338.611000	-53.7	-78.5	-40.7
824.040000	9888.348900	-53.7	-78.5	-40.7
836.400000	10036.656400	-52.7	-77.5	-39.7
848.970000	10187.603500	-51.8	-76.6	-38.8
824.040000	10712.416900	-53.1	-77.9	-40.1
836.400000	10872.995800	-53.2	-78	-40.2
848.970000	11036.822200	-53.5	-78.3	-40.5
824.040000	11536.565000	-53.7	-78.5	-40.7
836.400000	11709.761600	-52.8	-77.6	-39.8
848.970000	11885.340300	-52	-76.8	-39
824.040000	12360.735600	-51.9	-76.7	-38.9
836.400000	12545.813600	-48.9	-73.7	-35.9
848.970000	12734.404000	-48.8	-73.6	-35.8

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0230165: 2002-Mar-07 Thu 13:03:00
 STATE: 2:Low Power TDMA 800

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
824.040000	1648.072500	-69.1	-65	-56.1
836.400000	1672.751500	-79	-74.9	-66
848.970000	1697.931500	-71.6	-67.5	-58.6
824.040000	2472.117500	-67.6	-63.5	-54.6
836.400000	2509.066900	-78	-73.9	-65
848.970000	2546.849500	-77.7	-73.6	-64.7
824.040000	3296.326100	-80.1	-76	-67.1
836.400000	3345.372300	-78.9	-74.8	-65.9
848.970000	3395.908500	-78.9	-74.8	-65.9
824.040000	4120.233000	-79.1	-75	-66.1
836.400000	4182.017000	-79.8	-75.7	-66.8
848.970000	4244.955600	-78.9	-74.8	-65.9
824.040000	4944.267000	-79.4	-75.3	-66.4
836.400000	5018.437500	-79.1	-75	-66.1
848.970000	5094.029200	-79.7	-75.6	-66.7
824.040000	5768.394600	-79.2	-75.1	-66.2
836.400000	5854.725900	-74.1	-70	-61.1
848.970000	5942.765000	-72.2	-68.1	-59.2
824.040000	6592.422100	-73	-68.9	-60
836.400000	6691.064900	-71.8	-67.7	-58.8
848.970000	6791.614400	-72.7	-68.6	-59.7
824.040000	7416.474100	-73.4	-69.3	-60.4
836.400000	7527.481900	-73.2	-69.1	-60.2
848.970000	7640.559900	-73.6	-69.5	-60.6
824.040000	8240.374000	-73.6	-69.5	-60.6
836.400000	8364.075100	-74.1	-70	-61.1
848.970000	8489.927700	-73.7	-69.6	-60.7
824.040000	9064.380500	-73.6	-69.5	-60.6
836.400000	9200.519100	-74.2	-70.1	-61.2
848.970000	9338.525900	-74	-69.9	-61
824.040000	9888.708700	-72.6	-68.5	-59.6
836.400000	10036.954600	-74.1	-70	-61.1
848.970000	10187.486900	-73.4	-69.3	-60.4
824.040000	10712.704100	-74.1	-70	-61.1
836.400000	10873.420700	-73.5	-69.4	-60.5
848.970000	11036.595500	-74.2	-70.1	-61.2
824.040000	11536.764700	-72.5	-68.4	-59.5
836.400000	11709.769600	-73.6	-69.5	-60.6
848.970000	11885.442900	-72.7	-68.6	-59.7
824.040000	12360.351800	-72.1	-68	-59.1
836.400000	12545.900300	-67.6	-63.5	-54.6
848.970000	12734.504100	-69	-64.9	-56

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0230164: 2002-Mar-07 Thu 12:57:00
 STATE: 2:High Power TDMA 800

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
824.040000	1647.858800	-47.9	-75.4	-34.9
836.400000	1672.936600	-47.1	-74.6	-34.1
848.970000	1698.210000	-31.9	-59.4	-18.9
824.040000	2472.136500	-24.3	-51.8	-11.3
836.400000	2509.285100	-48.6	-76.1	-35.6
848.970000	2546.888000	-46.4	-73.9	-33.4
824.040000	3296.217000	-48.5	-76	-35.5
836.400000	3345.526900	-49.3	-76.8	-36.3
848.970000	3396.110700	-49.2	-76.7	-36.2
824.040000	4120.024900	-49.7	-77.2	-36.7
836.400000	4181.946500	-49.3	-76.8	-36.3
848.970000	4244.605300	-48.6	-76.1	-35.6
824.040000	4944.147900	-48.8	-76.3	-35.8
836.400000	5018.417500	-49.4	-76.9	-36.4
848.970000	5093.756900	-48.8	-76.3	-35.8
824.040000	5768.478700	-48.5	-76	-35.5
836.400000	5854.890100	-44.1	-71.6	-31.1
848.970000	5942.990700	-44.2	-71.7	-31.2
824.040000	6592.128300	-42.2	-69.7	-29.2
836.400000	6691.274100	-42.7	-70.2	-29.7
848.970000	6791.726000	-43.4	-70.9	-30.4
824.040000	7416.148800	-42.8	-70.3	-29.8
836.400000	7527.615000	-43.3	-70.8	-30.3
848.970000	7640.956200	-44	-71.5	-31
824.040000	8240.435500	-43.9	-71.4	-30.9
836.400000	8363.934900	-43.5	-71	-30.5
848.970000	8489.721500	-42.6	-70.1	-29.6
824.040000	9064.280400	-44.1	-71.6	-31.1
836.400000	9200.360000	-43.5	-71	-30.5
848.970000	9338.613000	-43.6	-71.1	-30.6
824.040000	9888.259800	-43	-70.5	-30
836.400000	10036.744000	-44.5	-72	-31.5
848.970000	10187.430300	-43.5	-71	-30.5
824.040000	10712.484000	-43.4	-70.9	-30.4
836.400000	10873.321600	-43.9	-71.4	-30.9
848.970000	11036.842700	-42.8	-70.3	-29.8
824.040000	11536.584500	-43.9	-71.4	-30.9
836.400000	11709.459900	-42.6	-70.1	-29.6
848.970000	11885.730600	-43.9	-71.4	-30.9
824.040000	12360.822200	-42.1	-69.6	-29.1
836.400000	12545.776200	-38.8	-66.3	-25.8
848.970000	12734.749400	-39.3	-66.8	-26.3

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NAME OF TEST: Field Strength of Spurious Radiation

SPECIFICATION: 47 CFR 2.1053(a)

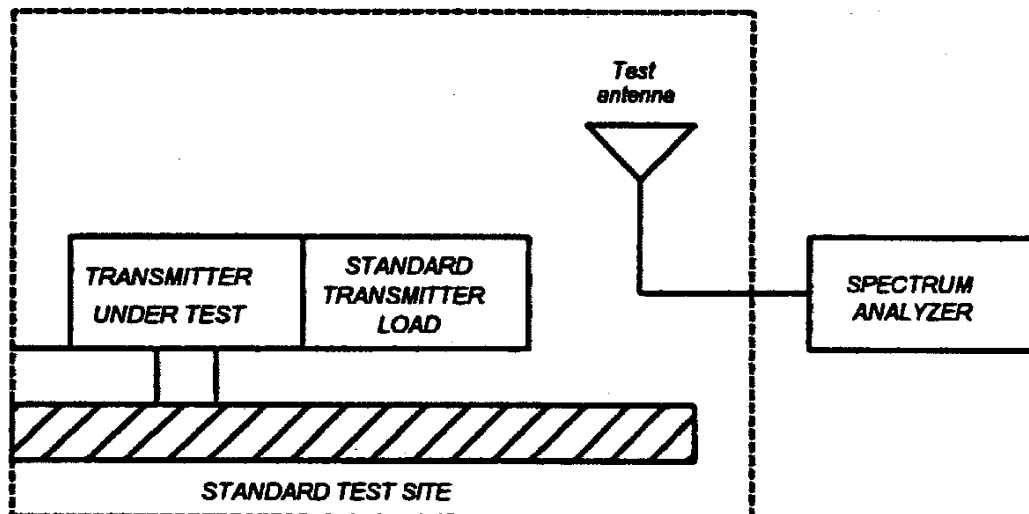
GUIDE: ANSI/TIA/EIA-603-1992/2001, Paragraph 1.2.12 and Table 16, 47 CFR 22.917

MEASUREMENT PROCEDURE

1.2.12.1 Definition: Radiated spurious emissions are emissions from the equipment when transmitting into a non-radiating load on a frequency or frequencies which are outside an occupied band sufficient to ensure transmission of information of required quality for the class of communications desired.

1.2.12.2 Method of Measurement

- A) Connect the equipment as illustrated
- B) Adjust the spectrum analyzer for the following settings:
 - 1) Resolution Bandwidth 10 kHz (<1 GHz), 1 MHz (> 1GHz).
 - 2) Video Bandwidth ≥ 3 times Resolution Bandwidth, or 30 kHz (22.917)
 - 3) Sweep Speed ≤ 2000 Hz/second
 - 4) Detector Mode = Mean or Average Power
- C) Place the transmitter to be tested on the turntable in the standard test site. The transmitter is transmitting into a non-radiating load which is placed on the turntable. The RF cable to this load should be of minimum length.



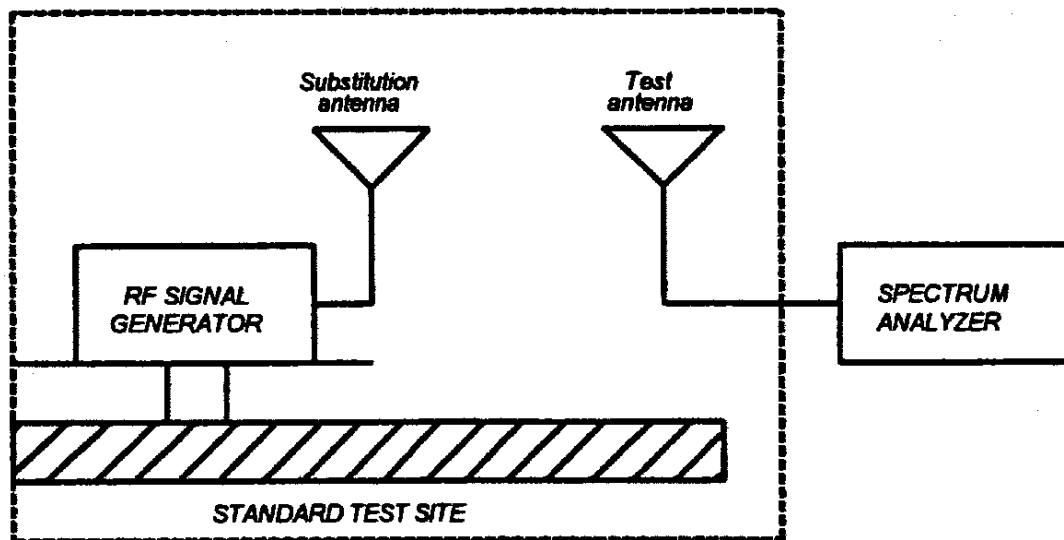
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NAME OF TEST:

Field Strength of Spurious Radiation (Cont.)

- D) For each spurious measurement the test antenna should be adjusted to the correct length for the frequency involved. This length may be determined from a calibration ruler supplied with the equipment. Measurements shall be made from the lowest radio frequency generated in the equipment to the tenth harmonic of the carrier, except for the region close to the carrier equal to $\pm$ the test bandwidth (see section 1.3.4.4).
- E) For each spurious frequency, raise and lower the test antenna from 1 m to 4 m to obtain a maximum reading on the spectrum analyzer with the test antenna at horizontal polarity. Repeat this procedure to obtain the highest possible reading. Record this maximum reading.
- F) Repeat step E) for each spurious frequency with the test antenna polarized vertically.



- G) Reconnect the equipment as illustrated.
- H) Keep the spectrum analyzer adjusted as in step B).
- I) Remove the transmitter and replace it with a substitution antenna (the antenna should be half-wavelength for each frequency involved). The center of the substitution antenna should be approximately at the same location as the center of the transmitter. At lower frequencies, where the substitution antenna is very long, this will be impossible to achieve when the antenna is polarized vertically. In such case the lower end of the antenna should be 0.3 m above the ground.

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NAME OF TEST: Field Strength of Spurious Radiation (Cont.)

- J) Feed the substitution antenna at the transmitter end with a signal generator connected to the antenna by means of a non-radiating cable. With the antennas at both ends horizontally polarized and with the signal generator tuned to a particular spurious frequency, raise and lower the test antenna to obtain a maximum reading at the spectrum analyzer. Adjust the level of the signal generator output until the previously recorded maximum reading for this set of conditions is obtained. This should be done carefully repeating the adjustment of the test antenna and generator output.
- K) Repeat step J) with both antennas vertically polarized for each spurious frequency.
- L) Calculate power in dBm into a reference ideal half-wave dipole antenna by reducing the readings obtained in steps J) and K) by the power loss in the cable between the generator and the antenna and further corrected for the gain of the substitution antenna used relative to an ideal half-wave dipole antenna.
- M) The levels recorded in step L) are absolute levels of radiated spurious emissions in dBm. The radiated spurious emissions in dB can be calculated by the following:

Radiated spurious emissions dB =
 $10\log_{10}(\text{TX power in watts}/0.001) - \text{the levels in step l)}$

NOTE: It is permissible that other antennas provided can be referenced to a dipole.

Test Equipment:

Asset Description (as applicable)	s/n	Cycle	Last Cal
Per ANSI C63.4-1992/2000 Draft, 10.1.4			
<u>TRANSDUCER</u>			
i00088 EMC0 3109-B 25MHz-300MHz	2336	12 mo.	Sep-01
i00065 EMC0 3301-B Active Monopole	2635	12 mo.	Sep-01
i00089 Aprel 2001 200MHz-1GHz	001500	12 mo.	Sep-01
i00103 EMC0 3115 1GHz-18GHz	9208-3925	12 mo.	Sep-01
<u>AMPLIFIER</u>			
i00028 HP 8449A	2749A00121	12 mo.	Mar-01
<u>SPECTRUM ANALYZER</u>			
i00029 HP 8563E	3213A00104	12 mo.	Jan-02
i00033 HP 85462A	3625A00357	12 mo.	Jan-02
i00048 HP 8566B	2511AD1467	6 mo.	Jan-02

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NAME OF TEST: Field Strength of Spurious Radiation

STATE: 2:High Power AMPS g0230131: 2002-Mar-05 Tue 08:46:00

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	ERP, dBm	ERP, dbc
836.400000	1672.778833	-49.4	-72.7
836.400000	2509.196300	-31.5	-54.8
836.400000	3345.614634	-47.7	-71.1
836.400000	4181.978833	-54	-73.3
836.400000	5018.389667	-55.1	-78.4
836.400000	5854.802167	-53.6	-76.9
836.400000	6691.203833	-53.5	-76.4
836.400000	7527.607167	-53.7	-77.0
836.400000	8364.003833	-51.7	-75.0

STATE: 2:High Power TDMA 800 g0230133: 2002-Mar-06 Wed 15:18:00

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	ERP, dBm	ERP, dbc
836.400000	1672.797134	-46	-72
836.400000	2509.187967	-26.2	-52.2
836.400000	3345.577967	-31.2	-57.2
836.400000	4181.982167	-43.8	-59.
836.400000	5018.389667	-48.4	-74.4
836.400000	5854.802167	-41.8	-67.8
836.400000	6691.202167	-53	-79.0
836.400000	7527.603000	-50.7	76.7
836.400000	8364.002167	-51	-77.0

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NAME OF TEST: Frequency Stability (Temperature Variation)
SPECIFICATION: 47 CFR 2.1055(d)(1)
TEST CONDITIONS: As Indicated
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

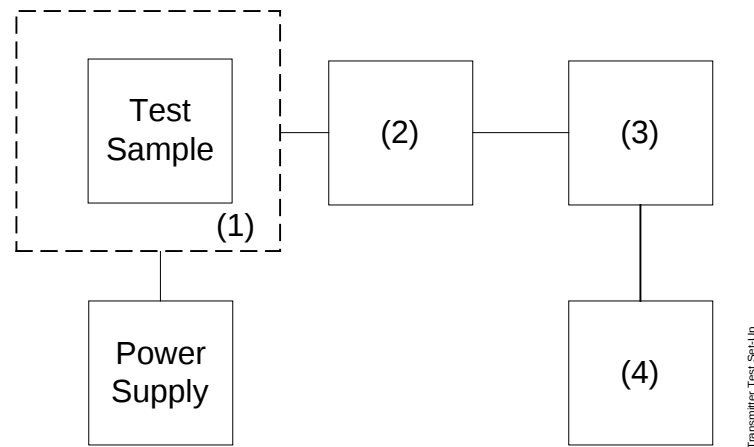
1. The EUT and test equipment were set up as shown on the following page.
2. With all power removed, the temperature was decreased to -30°C and permitted to stabilize for three hours. Power was applied and the maximum change in frequency was noted within one minute.
3. With power OFF, the temperature was raised in 10°C steps. The sample was permitted to stabilize at each step for at least one-half hour. Power was applied and the maximum frequency change was noted within one minute.
4. The temperature tests were performed for the worst case.
5. MEASUREMENT RESULTS: ATTACHED

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TRANSMITTER TEST SET-UP

TEST A. OPERATIONAL STABILITY
 TEST B. CARRIER FREQUENCY STABILITY
 TEST C. OPERATIONAL PERFORMANCE STABILITY
 TEST D. HUMIDITY
 TEST E. VIBRATION
 TEST F. ENVIRONMENTAL TEMPERATURE
 TEST G. FREQUENCY STABILITY: TEMPERATURE VARIATION
 TEST H. FREQUENCY STABILITY: VOLTAGE VARIATION



Asset	Description	s/n
(1)	TEMPERATURE, HUMIDITY, VIBRATION	
i00027	Tenney Temp. Chamber	9083-765-234
i00	Weber Humidity Chamber	
i00	L.A.B. RVH 18-100	
(2)	COAXIAL ATTENUATOR	
i00122	NARDA 766-10	7802
i00123	NARDA 766-10	7802A
i00113	SIERRA 661A-3D	1059
i00069	BIRD 8329 (30 dB)	10066
(3)	R.F. POWER	
i00014	HP 435A POWER METER	1733A05839
i00039	HP 436A POWER METER	2709A26776
i00020	HP 8901A POWER MODE	2105A01087
(4)	FREQUENCY COUNTER	
i00042	HP 5383A	1628A00959
i00019	HP 5334B	2704A00347
i00020	HP 8901A	2105A01087

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NAME OF TEST: Frequency Stability (Temperature Variation)

AMPS MODE

°C	Change, Hz	Change, ppm
-30	252	0.3
-20	250	0.3
-10	253	0.3
0	319	0.4
10	306	0.4
20	251	0.3
30	323	0.4
40	317	0.4
50	320	0.4

TDMA MODE

°C	Change, Hz	Change, ppm
-30	1.9	0.0
-20	-1.9	0.0
-10	0.9	0.0
0	6.3	0.0
10	0.3	0.0
20	-0.9	0.0
30	-7.2	0.0
40	-0.2	0.0
50	0.5	0.0

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NAME OF TEST: Frequency Stability (Voltage Variation)

SPECIFICATION: 47 CFR 2.1055 (b)(1)

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT was placed in a temperature chamber at $25\pm5^{\circ}\text{C}$ and connected as for "Frequency Stability - Temperature Variation" test.
2. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.
3. The variation in frequency was measured for the worst case.

AMPS MODE

BATTERY END POINT (Voltage) = 3.3

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	3.3	836.400251	251	0.3
100	3.9	836.400251	251	0.3
115	4.5	836.400251	251	0.3
B.E.P.	3.3	836.400251	251	0.3

TMDA MODE

BATTERY END POINT (Voltage) = 3.3

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	3.3	836.4000012	1.2	0.0
100	3.9	836.3999991	-0.9	0.0
115	4.5	836.4000021	2.1	0.0
B.E.P.	3.3	836.4000012	1.2	0.0

END OF TEST REPORT

TESTIMONIAL
AND
STATEMENT OF CERTIFICATION

THIS IS TO CERTIFY THAT:

1. THAT the application was prepared either by, or under the direct supervision of, the undersigned.
2. THAT the technical data supplied with the application was taken under my direction and supervision.
3. THAT the data was obtained on representative units, randomly selected.
4. THAT, to the best of my knowledge and belief, the facts set forth in the application and accompanying technical data are true and correct.

CERTIFYING ENGINEER:


Morton Flom, P. Eng.